256Mb M-die MLC NOR Specification

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Document Title

256M Bit (16M x16) Sync Burst , Multi Bank MLC NOR Flash Memory

Revision History

Revision No.	<u>History</u>	Draft Date	<u>Remark</u>
0.0	Initial	April 1, 2005	Advance
0.5	Preliminary	September 1, 2005	Preliminary
0.6	- Added Burst Access time(11ns@66Mhz, 9ns@83Mhz) - Correct the Active Write Current (typ.15mA, max.30mA> typ.25mA, max.40mA) - Correct tBDH(Data Hold Time from Next Clock Cycle) from 4ns(@66MHz), 2.25ns(@108MHz), 1.5ns(@133MHz) to 3ns(@66MHz), 2ns(@108MHz), 2ns(@133MHz) - Correct tRDYA(Clock to RDY Setup Time) from 8ns(@83Mhz) to 9ns(@83MHz) - Correct tRDYS(RDY setup to Clock) from 4ns(@66MHz), 2.25ns(@108MHz), 1.5ns(@133MHz) to 3ns(@66MHz), 2ns(@108MHz), 2ns(@133MHz) - Correct typo	November 7, 2005	Preliminary
0.7	- Add Ordering Information for Density 56: 256Mb for 66/83MHz, 57: 267Mb for 108/133Mhz - Add Product Classification Table (Table 1-1) - Change tAVDH(AVD Hold Time from CLK) from 6ns(@66MHz), 5ns(@83MHz) to 2ns(@66/83MHz) - Delete tOH(Output Hold Time from Address, CE or OE) from Asynchronous Read parameter	December 7, 2005	Preliminary
0.8	- CFI note is added (Max Operation frequency : Data 53H is in 66/83Mhz part	April 04,2006	Preliminary
1.0	tAVDO is deletedSpecification is finalized	April 25,2006	
1.1	Active Asynchronous read Current(@1Mhz) is changed 3mA(typ.),5mA(max.) to 8mA(typ.), 10mA(max.) 'In erase/program suspend followed by resume operation, min. 200ns is needed for checking the busy status' is added Frequency information is added to Programmable Wait State at Burst Mode Configuration Register Table. "Asynchronous mode may not support read following four sequential invalid read condition within 200ns." is added	September 08,2006	
1.2	Correct typo In write buffer programming part, "And from the third cycle to the last cycle of Write to Buffer command is also required when using Write-Buffer-Programming features in Unlock Bypass mode." is added.	October 17, 2006	
1.3	2 AC parameters are changed. At 66MHz and 83MHz, change tBDH form 3ns to 4ns. At 108MHz and 133MHz, change tBDH form 2ns to 3ns. Change tCES form 6ns to 5ns at all frequency regions. Add Synchronous Read Mode Setting by A19	October 19, 2006	
1.4	Change tCES form 5ns to 4.5ns at all frequency regions.	December 04, 2006	
1.5	Registered as a new part ID, K8C54(55)15ET(B)M. Ordering Information is updated.	December 27, 2006	



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256M Bit (16M x16) Synch Burst , Multi Bank MLC NOR Flash Memory

FEATURES

- Single Voltage, 1.7V to 1.95V for Read and Write operations
- Organization
 - 16,777,216 x 16 bit (Word Mode Only)
- Read While Program/Erase Operation
- Multiple Bank Architecture
 - 16 Banks (16Mb Partition)
- OTP Block : Extra 512-Word block
- Read Access Time (@ CL=30pF)
 - Asynchronous Random Access Time: 100ns
 - Synchronous Random Access Time: 100ns
 - Burst Access Time :

11ns(66Mhz) / 9ns(83Mhz) / 7ns (108MHz) / 6ns (133MHz)

- Burst Length:
 - Continuous Linear Burst
 - Linear Burst: 8-word & 16-word with No-wrap & Wrap
- Block Architecture
 - Four 16Kword blocks and two hundreds fifty-five 64Kword blocks
 - Bank 0 contains four 16 Kword blocks and fifteen 64Kword blocks
 - Bank 1 ~ Bank 15 contain two hundred forty 64Kword blocks
- Reduce program time using the VPP
- Support 32 words Buffer Program

- Power Consumption (Typical value, CL=30pF)
 - 16-word Synchronous Read Current: 35mA at 133MHz
 - Program/Erase Current: 25mA
 - Read While Program/Erase Current: 45mA
 - Standby Mode/Auto Sleep Mode: 30uA
- Block Protection/Unprotection
- Using the software command sequence
- Last two boot blocks are protected by WP=VIL
- All blocks are protected by VPP=VIL
- Handshaking Feature
 - Provides host system with minimum latency by monitoring RDY
- Erase Suspend/Resume
- Program Suspend/Resume
- Unlock Bypass Program/Erase
- Hardware Reset (RESET)
- Deep Power Down Mode
- Data Polling and Toggle Bits
 - Provides a software method of detecting the status of program or erase completion
- Endurance

100K Program/Erase Cycles Minimum

- Data Retention: 10 years
- Extended Temperature : -25°C ~ 85°C
- Support Common Flash Memory Interface
- Low Vcc Write Inhibit
- Package: 167-Ball FBGA type, 10.5mm x 14.0mm

0.8mm ball pitch

1.4mm (Max.) Thickness

GENERAL DEK8C54SCRIPTION

The K8C54(55)15E featuring single 1.8V power supply is a 256Mbit Burst Multi Bank Flash Memory organized as 16Mx16. The memory architecture of the device is designed to divide itsK8C55 memory arrays into 259 blocks with independent hardware protection. This block architecture provides highly flexible erase and program capability. The K8C54(55)15E NOR Flash consists of sixteen banks. This device is capable of reading data from one bank while programming or erasing in the other bank.

Regarding read access time, the K8C5415E provides an 11ns burst access time and an 100ns initial access time at 66MHz.

At 83Mhz, the K8C5415E provides an 9ns burst access time and an 100ns initial access time at 83MHz. At 108Mhz, the K8C5515E provides an 7ns burst access time and an 100ns initial access time at 83MHz. At 133MHz, the K8C5515E provides an 6ns burst access time and 100ns initial access time. The device performs a program operation in units of 16 bits (Word) and erases in units of a block. Single or multiple blocks can be erased. The block erase operation is completed within typically 0.6sec. The device requires 25mA as program/erase current in the extended temperature ranges.

The K8C54(55)15E NOR Flash Memory is created by using Samsung's advanced CMOS process technology.



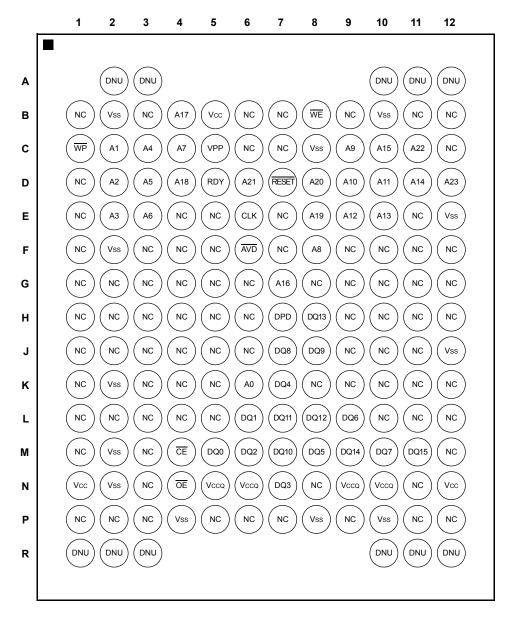
PIN DESCRIPTION

Pin Name	Pin Function
A0 - A23	Address Inputs
DQ0 - DQ15	Data input/output
CE	Chip Enable
ŌE	Output Enable
RESET	Hardware Reset Pin
Vpp	Accelerates Programming
WE	Write Enable
WP	Hardware Write Protection Input
CLK	Clock
RDY	Ready Output
AVD	Address Valid Input
DPD	Deep Power Down
Vcc	Power Supply
Vss	Ground

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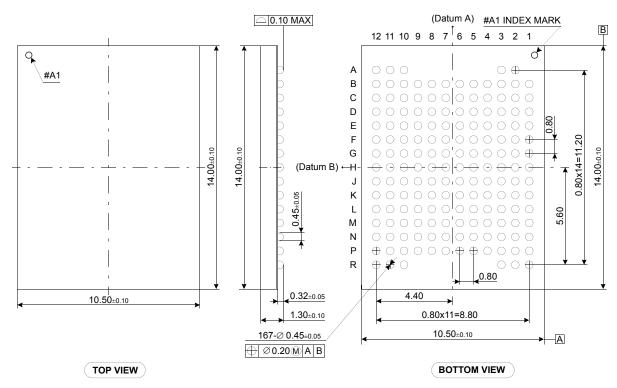


Pin Configuration

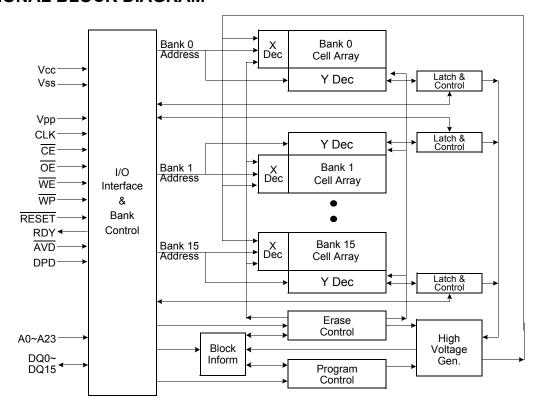


167-FBGA: Top View (Ball Down)

Ball FBGA VIEW



FUNCTIONAL BLOCK DIAGRAM





ORDERING INFORMATION

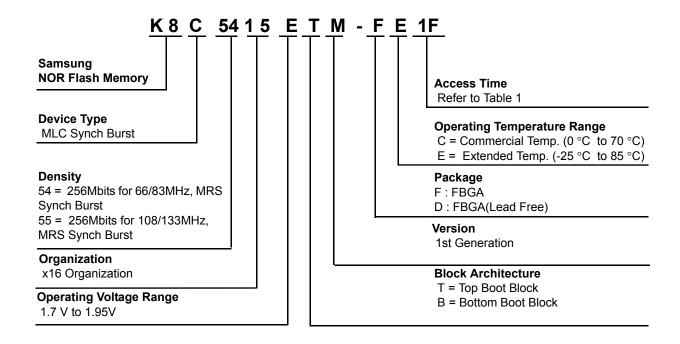


Table 1. Product Line-up

	K8C54(55)15ET						
	Mode	Speed Option	1C (66MHz)	1D (83MHz)	1E (108MHz)	1F (133MHz)	
	Vcc=1.7V- 1.95V	Max. Initial Access Time (tiAA, ns)	100	100	100	100	
		Max. Burst Access Time (tba, ns)	11	9	7	6	
		Max. Access Time (taa, ns)	100	100	100	100	
1.00 V		Max. CE Access Time (tce, ns)	100	100	100	100	
		Max. OE Access Time (toe, ns)	15	15	15	15	

Table 1-1. Product Classification

Speed/Boot Option	Тор	Bottom
256Mb for 66/83MHz	K8C5415ETM	K8C5415EBM
256Mb for 108/133MHz	K8C5515ETM	K8C5515EBM

Table 2. K8C54(55)15E DEVICE BANK DIVISIONS

Bank 0		Bank 1 ~ Bank 15	
Mbit	Block Sizes	Mbit	Block Sizes
16 Mbit	Four 16Kwords, fifteen 64Kwords	240 Mbit	Two hundred forty 64Kwords



Table 3-1. Top Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA258	16 Kwords	FFC000h-FFFFFh
-	BA257	16 Kwords	FF8000h-FFBFFFh
_	BA256	16 Kwords	FF4000h-FF7FFFh
	BA255	16 Kwords	FF0000h-FF3FFFh
	BA254	64 kwords	FE0000h-FEFFFFh
+	BA253	64 kwords	FD0000h-FDFFFFh
-	BA252	64 kwords	FC0000h-FCFFFFh
-	BA251	64 kwords	FB0000h-FBFFFFh
+	BA250	64 kwords	FA0000h-FAFFFFh
Bank 0	BA249	64 kwords	F90000h-F9FFFh
-	BA248	64 kwords	F80000h-F8FFFFh
-	BA247	64 kwords	F70000h-F7FFFh
-	BA246	64 kwords	F60000h-F6FFFh
-	BA245	64 kwords	F50000h-F5FFFh
=	BA244	64 kwords	F40000h-F4FFFh
=	BA243	64 kwords	F30000h-F3FFFh
=	BA242	64 kwords	F20000h-F2FFFFh
•	BA241	64 kwords	F10000h-F1FFFFh
=	BA240	64 kwords	F00000h-F0FFFh
	BA239	64 kwords	EF0000h-EFFFFh
-	BA238	64 kwords	EE0000h-EEFFFFh
=	BA237	64 kwords	ED0000h-EDFFFFh
-	BA236	64 kwords	EC0000h-ECFFFFh
-	BA235	64 kwords	EB0000h-EBFFFFh
-	BA234	64 kwords	EA0000h-EAFFFFh
-	BA233	64 kwords	E90000h-E9FFFh
5	BA232	64 kwords	E80000h-E8FFFFh
Bank 1	BA231	64 kwords	E70000h-E7FFFh
-	BA230	64 kwords	E60000h-E6FFFFh
-	BA229	64 kwords	E50000h-E5FFFh
-	BA228	64 kwords	E40000h-E4FFFh
-	BA227	64 kwords	E30000h-E3FFFh
-	BA226	64 kwords	E20000h-E2FFFFh
-	BA225	64 kwords	E10000h-E1FFFFh
-	BA224	64 kwords	E00000h-E0FFFFh
	BA223	64 kwords	DF0000h-DFFFFh
=	BA222	64 kwords	DE0000h-DEFFFFh
	BA221	64 kwords	DD0000h-DDFFFFh
	BA220	64 kwords	DC0000h-DCFFFFh
Bank 0	BA219	64 kwords	DB0000h-DBFFFFh
Bank 2	BA218	64 kwords	DA0000h-DAFFFFh
	BA217	64 kwords	D90000h-D9FFFFh
 	BA216	64 kwords	D80000h-D8FFFFh
 	BA215	64 kwords	D70000h-D7FFFFh
	BA214	64 kwords	D60000h-D6FFFFh



Table 3-1. Top Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA213	64 kwords	D50000h-D5FFFh
	BA212	64 kwords	D40000h-D4FFFh
David O	BA211	64 kwords	D30000h-D3FFFFh
Bank 2	BA210	64 kwords	D20000h-D2FFFFh
	BA209	64 kwords	D10000h-D1FFFFh
	BA208	64 kwords	D00000h-D0FFFFh
	BA207	64 kwords	CF0000h-CFFFFh
	BA206	64 kwords	CE0000h-CEFFFFh
	BA205	64 kwords	CD0000h-CDFFFh
	BA204	64 kwords	CC0000h-CCFFFh
	BA203	64 kwords	CB0000h-CBFFFFh
	BA202	64 kwords	CA0000h-CAFFFh
	BA201	64 kwords	C90000h-C9FFFh
	BA200	64 kwords	C80000h-C8FFFFh
Bank 3	BA199	64 kwords	C70000h-C7FFFh
	BA198	64 kwords	C60000h-C6FFFh
	BA197	64 kwords	C50000h-C5FFFFh
	BA196	64 kwords	C40000h-C4FFFFh
	BA195	64 kwords	C30000h-C3FFFFh
	BA194	64 kwords	C20000h-C2FFFFh
	BA193	64 kwords	C10000h-C1FFFFh
	BA192	64 kwords	C00000h-C0FFFFh
	BA191	64 kwords	BF0000h-BFFFFFh
	BA190	64 kwords	BE0000h-BEFFFFh
	BA189	64 kwords	BD0000h-BDFFFFh
	BA188	64 kwords	BC0000h-BCFFFFh
	BA187	64 kwords	BB0000h-BBFFFFh
	BA186	64 kwords	BA0000h-BAFFFFh
	BA185	64 kwords	B90000h-B9FFFFh
	BA184	64 kwords	B80000h-B8FFFFh
Bank 4	BA183	64 kwords	B70000h-B7FFFh
	BA182	64 kwords	B60000h-B6FFFFh
	BA181	64 kwords	B50000h-B5FFFh
	BA180	64 kwords	B40000h-B4FFFh
	BA179	64 kwords	B30000h-B3FFFFh
	BA178	64 kwords	B20000h-B2FFFFh
	BA177	64 kwords	B10000h-B1FFFFh B00000h-B0FFFFh
	BA176 BA175	64 kwords	AF0000h-AFFFFh
	BA174	64 kwords	AE0000h-AEFFFh
Ponk F	BA173	64 kwords	AD0000h ACEEER
Bank 5	BA172	64 kwords	AC0000h-ACFFFFh
	BA171	64 kwords	AB0000h-ABFFFFh
	BA170	64 kwords	AA0000h-AAFFFFh



Table 3-1. Top Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA168	64 kwords	A80000h-A8FFFFh
	BA167	64 kwords	A70000h-A7FFFh
-	BA166	64 kwords	A60000h-A6FFFFh
	BA165	64 kwords	A50000h-A5FFFFh
Bank 5	BA164	64 kwords	A40000h-A4FFFFh
	BA163	64 kwords	A30000h-A3FFFFh
	BA162	64 kwords	A20000h-A2FFFFh
	BA161	64 kwords	A10000h-A1FFFFh
	BA160	64 kwords	A00000h-A0FFFFh
	BA159	64 kwords	9F0000h-9FFFFh
	BA158	64 kwords	9E0000h-9EFFFh
	BA157	64 kwords	9D0000h-9DFFFFh
	BA156	64 kwords	9C0000h-9CFFFFh
	BA155	64 kwords	9B0000h-9BFFFFh
	BA154	64 kwords	9A0000h-9AFFFFh
	BA153	64 kwords	990000h-99FFFFh
	BA152	64 kwords	980000h-98FFFFh
Bank 6	BA151	64 kwords	970000h-97FFFh
	BA150	64 kwords	960000h-96FFFh
	BA149	64 kwords	950000h-95FFFh
	BA148	64 kwords	940000h-94FFFh
	BA147	64 kwords	930000h-93FFFFh
	BA146	64 kwords	920000h-92FFFFh
	BA145	64 kwords	910000h-91FFFFh
	BA144	64 kwords	900000h-90FFFh
	BA143	64 kwords	8F0000h-8FFFFFh
	BA142	64 kwords	8E0000h-8EFFFFh
	BA141	64 kwords	8D0000h-8DFFFFh
	BA140	64 kwords	8C0000h-8CFFFFh
	BA139	64 kwords	8B0000h-8BFFFFh
	BA138	64 kwords	8A0000h-8AFFFFh
	BA137	64 kwords	890000h-89FFFFh
Bank 7	BA136	64 kwords	880000h-88FFFFh
Bank 7	BA135	64 kwords	870000h-87FFFFh
	BA134	64 kwords	860000h-86FFFFh
	BA133	64 kwords	850000h-85FFFFh
	BA132	64 kwords	840000h-84FFFFh
	BA131	64 kwords	830000h-83FFFFh
	BA130	64 kwords	820000h-82FFFFh
	BA129	64 kwords	810000h-81FFFFh
	BA128	64 kwords	800000h-80FFFFh
	BA127	64 kwords	7F0000h-7FFFFFh
Bank 8	BA126	64 kwords	7E0000h-7EFFFFh
Danko	BA125	64 kwords	7D0000h-7DFFFFh
	BA124	64 kwords	7C0000h-7CFFFFh



Table 3-1. Top Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA123	64 kwords	7B0000h-7BFFFFh
	BA122	64 kwords	7A0000h-7AFFFFh
	BA121	64 kwords	790000h-79FFFFh
	BA120	64 kwords	780000h-78FFFFh
	BA119	64 kwords	770000h-77FFFFh
Danis 0	BA118	64 kwords	760000h-76FFFFh
Bank 8	BA117	64 kwords	750000h-75FFFFh
	BA116	64 kwords	740000h-74FFFFh
	BA115	64 kwords	730000h-73FFFFh
	BA114	64 kwords	720000h-72FFFFh
	BA113	64 kwords	710000h-71FFFFh
	BA112	64 kwords	700000h-70FFFFh
	BA111	64 kwords	6F0000h-6FFFFh
	BA110	64 kwords	6E0000h-6EFFFFh
	BA109	64 kwords	6D0000h-6DFFFFh
	BA108	64 kwords	6C0000h-6CFFFFh
	BA107	64 kwords	6B0000h-6BFFFFh
	BA106	64 kwords	6A0000h-6AFFFFh
	BA105	64 kwords	690000h-69FFFh
Darel O	BA104	64 kwords	680000h-68FFFFh
Bank 9	BA103	64 kwords	670000h-67FFFh
	BA102	64 kwords	660000h-66FFFFh
	BA101	64 kwords	650000h-65FFFFh
	BA100	64 kwords	640000h-64FFFh
	BA99	64 kwords	630000h-63FFFFh
	BA98	64 kwords	620000h-62FFFFh
	BA97	64 kwords	610000h-61FFFh
	BA96	64 kwords	600000h-60FFFh
	BA95	64 kwords	5F0000h-5FFFFh
	BA94	64 kwords	5E0000h-5EFFFFh
	BA93	64 kwords	5D0000h-5DFFFFh
	BA92	64 kwords	5C0000h-5CFFFFh
	BA91	64 kwords	5B0000h-5BFFFFh
	BA90	64 kwords	5A0000h-5AFFFFh
	BA89	64 kwords	590000h-59FFFh
Bank 10	BA88	64 kwords	580000h-58FFFFh
שמות וט	BA87	64 kwords	570000h-57FFFh
	BA86	64 kwords	560000h-56FFFFh
	BA85	64 kwords	550000h-55FFFFh
	BA84	64 kwords	540000h-54FFFFh
	BA83	64 kwords	530000h-53FFFFh
	BA82	64 kwords	520000h-52FFFFh
	BA81	64 kwords	510000h-51FFFFh
	BA80	64 kwords	500000h-50FFFh



Table 3-1. Top Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA79	64 kwords	4F0000h-4FFFFh
	BA78	64 kwords	4E0000h-4EFFFFh
	BA77	64 kwords	4D0000h-4DFFFFh
	BA76	64 kwords	4C0000h-4CFFFFh
	BA75	64 kwords	4B0000h-4BFFFFh
	BA74	64 kwords	4A0000h-4AFFFFh
	BA73	64 kwords	490000h-49FFFFh
 	BA72	64 kwords	480000h-48FFFFh
Bank 11	BA71	64 kwords	470000h-47FFFFh
	BA70	64 kwords	460000h-46FFFFh
	BA69	64 kwords	450000h-45FFFFh
	BA68	64 kwords	440000h-44FFFFh
	BA67	64 kwords	430000h-43FFFFh
	BA66	64 kwords	420000h-42FFFFh
	BA65	64 kwords	410000h-41FFFFh
	BA64	64 kwords	400000h-40FFFFh
	BA63	64 kwords	3F0000h-3FFFFh
	BA62	64 kwords	3E0000h-3EFFFFh
	BA61	64 kwords	3D0000h-3DFFFFh
	BA60	64 kwords	3C0000h-3CFFFFh
	BA59	64 kwords	3B0000h-3BFFFFh
	BA58	64 kwords	3A0000h-3AFFFFh
	BA57	64 kwords	390000h-39FFFFh
David 40	BA56	64 kwords	380000h-38FFFFh
Bank 12	BA55	64 kwords	370000h-37FFFFh
	BA54	64 kwords	360000h-36FFFFh
	BA53	64 kwords	350000h-35FFFFh
	BA52	64 kwords	340000h-34FFFFh
	BA51	64 kwords	330000h-33FFFFh
	BA50	64 kwords	320000h-32FFFFh
	BA49	64 kwords	310000h-31FFFFh
	BA48	64 kwords	300000h-30FFFFh
	BA47	64 kwords	2F0000h-2FFFFh
	BA46	64 kwords	2E0000h-2EFFFFh
	BA45	64 kwords	2D0000h-2DFFFFh
	BA44	64 kwords	2C0000h-2CFFFFh
	BA43	64 kwords	2B0000h-2BFFFFh
	BA42	64 kwords	2A0000h-2AFFFh
Bank 13	BA41	64 kwords	290000h-29FFFFh
	BA40	64 kwords	280000h-28FFFFh
	BA39	64 kwords	270000h-27FFFFh
	BA38	64 kwords	260000h-26FFFFh
	BA37	64 kwords	250000h-25FFFFh
	BA36	64 kwords	240000h-24FFFFh
	BA35	64 kwords	230000h-23FFFFh



Table 3-1. Top Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA34	64 kwords	220000h-22FFFFh
Bank 13	BA33	64 kwords	210000h-21FFFFh
	BA32	64 kwords	200000h-20FFFFh
	BA31	64 kwords	1F0000h-1FFFFh
	BA30	64 kwords	1E0000h-1EFFFFh
	BA29	64 kwords	1D0000h-1DFFFFh
	BA28	64 kwords	1C0000h-1CFFFFh
	BA27	64 kwords	1B0000h-1BFFFFh
	BA26	64 kwords	1A0000h-1AFFFFh
	BA25	64 kwords	190000h-19FFFFh
Donk 14	BA24	64 kwords	180000h-18FFFFh
Bank 14	BA23	64 kwords	170000h-17FFFFh
	BA22	64 kwords	160000h-16FFFFh
	BA21	64 kwords	150000h-15FFFFh
	BA20	64 kwords	140000h-14FFFh
	BA19	64 kwords	130000h-13FFFFh
	BA18	64 kwords	120000h-12FFFFh
	BA17	64 kwords	110000h-11FFFFh
	BA16	64 kwords	100000h-10FFFFh
	BA15	64 kwords	0F0000h-0FFFFh
	BA14	64 kwords	0E0000h-0EFFFFh
	BA13	64 kwords	0D0000h-0DFFFFh
	BA12	64 kwords	0C0000h-0CFFFFh
	BA11	64 kwords	0B0000h-0BFFFFh
	BA10	64 kwords	0A0000h-0AFFFFh
	BA9	64 kwords	090000h-09FFFh
Danis 45	BA8	64 kwords	080000h-08FFFFh
Bank 15	BA7	64 kwords	070000h-07FFFh
	BA6	64 kwords	060000h-06FFFh
	BA5	64 kwords	050000h-05FFFh
	BA4	64 kwords	040000h-04FFFh
	BA3	64 kwords	030000h-03FFFFh
	BA2	64 kwords	020000h-02FFFFh
	BA1	64 kwords	010000h-01FFFFh
	BA0	64 kwords	000000h-00FFFFh

Table 3-1-1. OTP Block Addresses

ОТР	Block Address A23 ~ A8	Block Size	(x16) Address Range*		
	FFFFh	512words	FFFE00h-FFFFFFh		

After entering OTP Block, any issued addresses should be in the range of OTP block address.



Table 3-2. Bottom Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA258	64 Kwords	FF0000h-FFFFFh
	BA257	64 Kwords	FE0000h-FEFFFh
	BA256	64 Kwords	FD0000h-FDFFFFh
	BA255	64 Kwords	FC0000h-FCFFFFh
	BA254	64 kwords	FB0000h-FBFFFFh
	BA253	64 kwords	FA0000h-FAFFFFh
	BA252	64 kwords	F90000h-F9FFFh
	BA251	64 kwords	F80000h-F8FFFFh
Bank 15	BA250	64 kwords	F70000h-F7FFFFh
	BA249	64 kwords	F60000h-F6FFFh
	BA248	64 kwords	F50000h-F5FFFh
	BA247	64 kwords	F40000h-F4FFFFh
	BA246	64 kwords	F30000h-F3FFFFh
	BA245	64 kwords	F20000h-F2FFFh
	BA244	64 kwords	F10000h-F1FFFh
	BA243	64 kwords	F00000h-F0FFFh
	BA242	64 kwords	EF0000h-EFFFFh
	BA241	64 kwords	EE0000h-EEFFFFh
	BA240	64 kwords	ED0000h-EDFFFFh
	BA239	64 kwords	EC0000h-ECFFFFh
	BA238	64 kwords	EB0000h-EBFFFFh
	BA237	64 kwords	EA0000h-EAFFFFh
	BA236	64 kwords	E90000h-E9FFFh
	BA235	64 kwords	E80000h-E8FFFFh
Bank 14	BA234	64 kwords	E70000h-E7FFFh
	BA233	64 kwords	E60000h-E6FFFh
	BA232	64 kwords	E50000h-E5FFFFh
	BA231	64 kwords	E40000h-E4FFFFh
	BA230	64 kwords	E30000h-E3FFFFh
	BA229	64 kwords	E20000h-E2FFFh
	BA228	64 kwords	E10000h-E1FFFh
	BA227	64 kwords	E00000h-E0FFFh
	BA226	64 kwords	DF0000h-DFFFFh
	BA225	64 kwords	DE0000h-DEFFFFh
	BA224	64 kwords	DD0000h-DDFFFFh
	BA223	64 kwords	DC0000h-DCFFFFh
	BA222	64 kwords	DB0000h-DBFFFFh
	BA221	64 kwords	DA0000h-DAFFFFh
Bank 13	BA220	64 kwords	D90000h-D9FFFFh
	BA219	64 kwords	D80000h-D8FFFFh
	BA218	64 kwords	D70000h-D7FFFh
	BA217	64 kwords	D60000h-D6FFFFh
	BA216	64 kwords	D50000h-D5FFFFh
	BA215	64 kwords	D40000h-D4FFFFh
	BA214	64 kwords	D30000h-D3FFFFh
	<u> </u>		<u> </u>



Table 3-2. Bottom Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA213	64 kwords	D20000h-D2FFFFh
Bank 13	BA212	64 kwords	D10000h-D1FFFFh
	BA211	64 kwords	D00000h-D0FFFFh
	BA210	64 kwords	CF0000h-CFFFFh
	BA209	64 kwords	CE0000h-CEFFFFh
	BA208	64 kwords	CD0000h-CDFFFFh
	BA207	64 kwords	CC0000h-CCFFFFh
	BA206	64 kwords	CB0000h-CBFFFFh
	BA205	64 kwords	CA0000h-CAFFFh
	BA204	64 kwords	C90000h-C9FFFFh
	BA203	64 kwords	C80000h-C8FFFFh
Bank 12	BA202	64 kwords	C70000h-C7FFFh
	BA201	64 kwords	C60000h-C6FFFFh
	BA200	64 kwords	C50000h-C5FFFFh
	BA199	64 kwords	C40000h-C4FFFFh
	BA198	64 kwords	C30000h-C3FFFFh
	BA197	64 kwords	C20000h-C2FFFFh
	BA196	64 kwords	C10000h-C1FFFFh
	BA195	64 kwords	C00000h-C0FFFFh
	BA194	64 kwords	BF0000h-BFFFFFh
	BA193	64 kwords	BE0000h-BEFFFFh
	BA192	64 kwords	BD0000h-BDFFFFh
	BA191	64 kwords	BC0000h-BCFFFFh
	BA190	64 kwords	BB0000h-BBFFFFh
	BA189	64 kwords	BA0000h-BAFFFFh
	BA188	64 kwords	B90000h-B9FFFFh
Donk 11	BA187	64 kwords	B80000h-B8FFFFh
Bank 11	BA186	64 kwords	B70000h-B7FFFFh
	BA185	64 kwords	B60000h-B6FFFFh
	BA184	64 kwords	B50000h-B5FFFFh
	BA183	64 kwords	B40000h-B4FFFFh
	BA182	64 kwords	B30000h-B3FFFFh
	BA181	64 kwords	B20000h-B2FFFFh
	BA180	64 kwords	B10000h-B1FFFFh
	BA179	64 kwords	B00000h-B0FFFFh
	BA178	64 kwords	AF0000h-AFFFFh
	BA177	64 kwords	AE0000h-AEFFFFh
	BA176	64 kwords	AD0000h-ADFFFFh
	BA175	64 kwords	AC0000h-ACFFFh
Rank 10	BA174	64 kwords	AB0000h-ABFFFFh
Dalik IU	BA173	64 kwords	AA0000h-AAFFFh
Bank 10	BA172	64 kwords	A90000h-A9FFFFh
,	BA171	64 kwords	A80000h-A8FFFFh
	BA170	64 kwords	A70000h-A7FFFFh
	BA169	64 kwords	A60000h-A6FFFFh



Table 3-2. Bottom Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA168	64 kwords	A50000h-A5FFFFh
-	BA167	64 kwords	A40000h-A4FFFh
-	BA166	64 kwords	A30000h-A3FFFFh
Bank 10	BA165	64 kwords	A20000h-A2FFFFh
-	BA164	64 kwords	A10000h-A1FFFFh
-	BA163	64 kwords	A00000h-A0FFFFh
	BA162	64 kwords	9F0000h-9FFFFh
-	BA161	64 kwords	9E0000h-9EFFFFh
-	BA160	64 kwords	9D0000h-9DFFFFh
-	BA159	64 kwords	9C0000h-9CFFFh
-	BA158	64 kwords	9B0000h-9BFFFFh
-	BA157	64 kwords	9A0000h-9AFFFFh
-	BA156	64 kwords	990000h-99FFFFh
	BA155	64 kwords	980000h-98FFFFh
Bank 9	BA154	64 kwords	970000h-97FFFFh
-	BA153	64 kwords	960000h-96FFFFh
-	BA152	64 kwords	950000h-95FFFFh
-	BA151	64 kwords	940000h-94FFFFh
	BA150	64 kwords	930000h-93FFFFh
	BA149	64 kwords	920000h-92FFFFh
-	BA148	64 kwords	910000h-91FFFFh
-	BA147	64 kwords	900000h-90FFFFh
	BA146	64 kwords	8F0000h-8FFFFFh
-	BA145	64 kwords	8E0000h-8EFFFFh
-	BA144	64 kwords	8D0000h-8DFFFFh
-	BA143	64 kwords	8C0000h-8CFFFFh
-	BA142	64 kwords	8B0000h-8BFFFFh
	BA141	64 kwords	8A0000h-8AFFFFh
-	BA140	64 kwords	890000h-89FFFFh
Develo 0	BA139	64 kwords	880000h-88FFFFh
Bank 8	BA138	64 kwords	870000h-87FFFFh
-	BA137	64 kwords	860000h-86FFFFh
	BA136	64 kwords	850000h-85FFFFh
-	BA135	64 kwords	840000h-84FFFFh
-	BA134	64 kwords	830000h-83FFFFh
-	BA133	64 kwords	820000h-82FFFFh
-	BA132	64 kwords	810000h-81FFFFh
	BA131	64 kwords	800000h-80FFFFh
	BA130	64 kwords	7F0000h-7FFFFFh
	BA129	64 kwords	7E0000h-7EFFFFh
	BA128	64 kwords	7D0000h-7DFFFFh
Bank 7	BA127	64 kwords	7C0000h-7CFFFFh
	BA126	64 kwords	7B0000h-7BFFFFh
	BA125	64 kwords	7A0000h-7AFFFFh
	BA124	64 kwords	790000h-79FFFFh



Table 3-2. Bottom Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA123	64 kwords	780000h-78FFFFh
	BA122	64 kwords	770000h-77FFFFh
	BA121	64 kwords	760000h-76FFFFh
	BA120	64 kwords	750000h-75FFFFh
Bank 7	BA119	64 kwords	740000h-74FFFFh
	BA118	64 kwords	730000h-73FFFFh
	BA117	64 kwords	720000h-72FFFFh
	BA116	64 kwords	710000h-71FFFFh
	BA115	64 kwords	700000h-70FFFFh
	BA114	64 kwords	6F0000h-6FFFFh
	BA113	64 kwords	6E0000h-6EFFFFh
	BA112	64 kwords	6D0000h-6DFFFFh
	BA111	64 kwords	6C0000h-6CFFFh
	BA110	64 kwords	6B0000h-6BFFFFh
	BA109	64 kwords	6A0000h-6AFFFh
	BA108	64 kwords	690000h-69FFFh
Davids C	BA107	64 kwords	680000h-68FFFFh
Bank 6	BA106	64 kwords	670000h-67FFFh
	BA105	64 kwords	660000h-66FFFFh
	BA104	64 kwords	650000h-65FFFh
	BA103	64 kwords	640000h-64FFFh
	BA102	64 kwords	630000h-63FFFFh
	BA101	64 kwords	620000h-62FFFFh
	BA100	64 kwords	610000h-61FFFFh
	BA99	64 kwords	600000h-60FFFh
	BA98	64 kwords	5F0000h-5FFFFh
	BA97	64 kwords	5E0000h-5EFFFFh
	BA96	64 kwords	5D0000h-5DFFFFh
	BA95	64 kwords	5C0000h-5CFFFFh
	BA94	64 kwords	5B0000h-5BFFFFh
	BA93	64 kwords	5A0000h-5AFFFFh
	BA92	64 kwords	590000h-59FFFFh
Bank 5	BA91	64 kwords	580000h-58FFFFh
Dalik 3	BA90	64 kwords	570000h-57FFFFh
	BA89	64 kwords	560000h-56FFFFh
	BA88	64 kwords	550000h-55FFFFh
	BA87	64 kwords	540000h-54FFFFh
	BA86	64 kwords	530000h-53FFFFh
	BA85	64 kwords	520000h-52FFFFh
<u>-</u>	BA84	64 kwords	510000h-51FFFFh
	BA83	64 kwords	500000h-50FFFFh
	BA82	64 kwords	4F0000h-4FFFFFh
Bank 4	BA81	64 kwords	4E0000h-4EFFFFh
	BA80	64 kwords	4D0000h-4DFFFFh



Table 3-2. Bottom Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA79	64 kwords	4C0000h-4CFFFFh
	BA78	64 kwords	4B0000h-4BFFFFh
	BA77	64 kwords	4A0000h-4AFFFFh
	BA76	64 kwords	490000h-49FFFFh
	BA75	64 kwords	480000h-48FFFFh
	BA74	64 kwords	470000h-47FFFFh
Bank 4	BA73	64 kwords	460000h-46FFFFh
	BA72	64 kwords	450000h-45FFFFh
	BA71	64 kwords	440000h-44FFFFh
	BA70	64 kwords	430000h-43FFFFh
	BA69	64 kwords	420000h-42FFFFh
	BA68	64 kwords	410000h-41FFFh
	BA67	64 kwords	400000h-40FFFh
	BA66	64 kwords	3F0000h-3FFFFh
	BA65	64 kwords	3E0000h-3EFFFFh
	BA64	64 kwords	3D0000h-3DFFFFh
	BA63	64 kwords	3C0000h-3CFFFFh
	BA62	64 kwords	3B0000h-3BFFFFh
	BA61	64 kwords	3A0000h-3AFFFFh
	BA60	64 kwords	390000h-39FFFFh
Bank 3	BA59	64 kwords	380000h-38FFFFh
Dalik 3	BA58	64 kwords	370000h-37FFFFh
	BA57	64 kwords	360000h-36FFFFh
	BA56	64 kwords	350000h-35FFFFh
	BA55	64 kwords	340000h-34FFFFh
	BA54	64 kwords	330000h-33FFFFh
	BA53	64 kwords	320000h-32FFFFh
	BA52	64 kwords	310000h-31FFFFh
	BA51	64 kwords	300000h-30FFFFh
	BA50	64 kwords	2F0000h-2FFFFh
	BA49	64 kwords	2E0000h-2EFFFFh
	BA48	64 kwords	2D0000h-2DFFFFh
	BA47	64 kwords	2C0000h-2CFFFFh
	BA46	64 kwords	2B0000h-2BFFFFh
	BA45	64 kwords	2A0000h-2AFFFFh
	BA44	64 kwords	290000h-29FFFFh
Bank 2	BA43	64 kwords	280000h-28FFFFh
Dunk	BA42	64 kwords	270000h-27FFFFh
	BA41	64 kwords	260000h-26FFFFh
	BA40	64 kwords	250000h-25FFFFh
	BA39	64 kwords	240000h-24FFFFh
	BA38	64 kwords	230000h-23FFFFh
	BA37	64 kwords	220000h-22FFFFh
	BA36	64 kwords	210000h-21FFFFh
	BA35	64 kwords	200000h-20FFFFh



Table 3-2. Bottom Boot Block Address Table

Bank	Block	Block Size	(x16) Address Range
	BA34	64 kwords	1F0000h-1FFFFFh
	BA33	64 kwords	1E0000h-1EFFFFh
	BA32	64 kwords	1D0000h-1DFFFFh
	BA31	64 kwords	1C0000h-1CFFFFh
	BA30	64 kwords	1B0000h-1BFFFFh
	BA29	64 kwords	1A0000h-1AFFFFh
	BA28	64 kwords	190000h-19FFFFh
Bank 1	BA27	64 kwords	180000h-18FFFFh
Dank i	BA26	64 kwords	170000h-17FFFFh
	BA25	64 kwords	160000h-16FFFFh
	BA24	64 kwords	150000h-15FFFFh
	BA23	64 kwords	140000h-14FFFFh
	BA22	64 kwords	130000h-13FFFFh
	BA21	64 kwords	120000h-12FFFFh
	BA20	64 kwords	110000h-11FFFFh
	BA19	64 kwords	100000h-10FFFFh
	BA18	64 kwords	0F0000h-0FFFFh
	BA17	64 kwords	0E0000h-0EFFFFh
	BA16	64 kwords	0D0000h-0DFFFFh
	BA15	64 kwords	0C0000h-0CFFFFh
	BA14	64 kwords	0B0000h-0BFFFFh
	BA13	64 kwords	0A0000h-0AFFFh
	BA12	64 kwords	090000h-09FFFFh
	BA11	64 kwords	080000h-08FFFFh
	BA10	64 kwords	070000h-07FFFFh
Bank 0	BA9	64 kwords	060000h-06FFFFh
	BA8	64 kwords	050000h-05FFFFh
	BA7	64 kwords	040000h-04FFFFh
	BA6	64 kwords	030000h-03FFFFh
	BA5	64 kwords	020000h-02FFFFh
	BA4	64 kwords	010000h-01FFFFh
	BA3	16 kwords	00C000h-00FFFFh
	BA2	16 kwords	008000h-00BFFFh
	BA1	16 kwords	004000h-007FFFh
	BA0	16 kwords	000000h-003FFFh

Table 3-2-1. OTP Block Addresses

ОТР	Block Address A23 ~ A8	Block Size	(x16) Address Range*		
	0000h	512 words	000000h-0001FFh		

After entering OTP Block, any issued addresses should be in the range of OTP block address.



PRODUCT INSTRUCTION

The K8C54(55)15E is an 256Mbit (268,435,456 bits) NOR-type Burst Flash memory. The device features 1.8V single voltage power supply operating within the range of 1.7V to 1.95V. The device is programmed by using the Channel Hot Electron (CHE) injection mechanism which is used to program EPROMs. The device is erased electrically by using Fowler-Nordheim tunneling mechanism. To provide highly flexible erase and program capability, the device adapts a block memory architecture that divides its memory array into 259 blocks (64-Kword x255, 16-Kword x 4,). Programming is done in units of 16 bits (Word). All bits of data in one or multiple blocks can be erased when the device executes the erase operation. To prevent the device from accidental erasing or over-writing the programmed data, 259 memory blocks can be hardware protected. Regarding read access time, at 66MHz, the K8C5415E provides a burst access of 11ns with initial access times of 100ns at 30pF. At 83MHz, the K8C5415E provides a burst access of 9ns with initial access times of 100ns at 30pF. At 108MHz, the K8C5515E provides a burst access of 7ns with initial access times of 100ns at 30pF. At 133MHz, the K8C5515E provides a burst access of 6ns with initial access times of 100ns at 30pF. The command set of K8C54(55)15E is compatible with standard Flash devices. The device uses Chip Enable (\overline{CE}) , Write Enable (\overline{WE}) , Output Enable (\overline{OE}) to control asynchronous read and write operation. For burst operations, the device additionally requires Ready (RDY) and Clock (CLK). Device operations are executed by selective command codes. The command codes to be combined with addresses and data are sequentially written to the command registers using microprocessor write timing. The command codes serve as inputs to an internal state machine which controls the program/erase circuitry. Register contents also internally latch addresses and data necessary to execute the program and erase operations. The K8C54(55)15E is implemented with Internal Program/Erase Routines to execute the program/erase operations. The Internal Program/Erase Routines are invoked by program/erase command sequences. The Internal Program Routine automatically programs and verifies data at specified addresses. The Internal Erase Routine automatically pre-programs the memory cell which is not programmed and then executes the erase operation. The K8C54(55)15E has means to indicate the status of completion of program/erase operations. The status can be indicated via Data polling of DQ7, or the Toggle bit (DQ6). Once the operations have been completed, the device automatically resets itself to the read mode. The device requires only 35 mA as burst and asynchronous mode read current and 25 mA for program/erase operations.

Table 4. Device Bus Operations

Operation	CE	OE	WE	A0-23	DQ0-15	RESET	CLK	AVD
Asynchronous Read Operation	L	L	Н	Add In	I/O	Н	L	L
Write	L	Н		Add In	I/O	Н	L	Х
Standby	Н	Х	х	Х	High-Z	Н	Х	Х
Hardware Reset	х	Х	х	Х	High-Z	L	Х	Х
Load Initial Burst Address	L	Н	Н	Add In	Х	Н		
Burst Read Operation	L	L	Н	Х	Burst Dout	Н		Н
Terminate Burst Read Cycle	Н	Х	x	Х	High-Z	Н	Х	X
Terminate Burst Read Cycle via RESET	Х	Х	Х	Х	High-Z	L	Х	Х
Terminate Current Burst Read Cycle and Start New Burst Read Cycle	L	Н	Н	Add In	I/O	Н		

NOTE

L=VIL (Low), H=VIH (High), X=Don't Care.



COMMAND DEFINITIONS

The K8C54(55)15E operates by selecting and executing its operational modes. Each operational mode has its own command set. In order to select a certain mode, a proper command with specific address and data sequences must be written into the command register. Writing incorrect information which include address and data or writing an improper command will reset the device to the read mode. The defined valid register command sequences are stated in Table 5.

Table 5. Command Sequences

Command Definitions		Cycle	1st Cycle	2nd Cycle	3rd Cycle	4th Cycle	5th Cycle	6th Cycle
	Add		RA					
Asynchronous Read	Data	1	RD					
	Add		XXXH					
Reset(Note 5)	Data	1	F0H					
Autoselect	Add	_	555H	2AAH	(DA)555H	(DA)X00H		
Manufacturer ID(Note 6)	Data	4	AAH	55H	90H	ECH		
Autoselect	Add		555H	2AAH	(DA)555H	(DA)X01H		
Device ID(Note 6)	Data	Add 1 F Data 1 F Add 1 F Add 4 A Data 4 A Add 4 A Data 4 A Add 4 A Data 4 A Add 4 A Add 5 A Add 3 A Add 2 A Add 5 A Add 6 A Add 7 A Add 1 A Add 1 A Add 1 A Add 1 A	AAH	55H	90H	Note6		
Autoselect	Add		555H	2AAH	(BA)555H	(BA)X02H		
Block Protection Verify(Note 7)	Data	4	AAH	55H	90H	00H/01H		
Autoselect	Add	_	555H	2AAH	(DA)555H	(DA)X03H		
Handshaking(Note 6, 8)	Data	4	AAH	55H	90H	0H/1H		
	Add	_	555H	2AAH	555H	PA		
Program	Data	4	AAH	55H	A0H	PD		
Helesis D.	Add	_	555H	2AAH	555H			
Unlock Bypass	Data	3	AAH	55H	20H			
	Add	2	XXX	PA				
Unlock Bypass Program(Note 9)	Data		A0H	PD				
	Add	2	XXX	ВА				
Unlock Bypass Block Erase(Note 9)	Data		80H	30H				
	Add	_	XXXH	XXXH				
Unlock Bypass Chip Erase(Note 9)	Data	2	80H	10H				
	Add	_	XXXH	XXXH				
Unlock Bypass Reset	Data	2	90H	00H				
	Add	_	1 RD	555H				
Chip Erase	Data	6	AAH	55H	80H	AAH	55H	10H
	Data	ВА						
Data Add Add	AAH	55H	80H	AAH	55H	30H		
	Add	_	(DA)XXXH					
Erase Suspend (Note 10)	Data	1	вон					
	Add		(DA)XXXH					
Erase Resume (Note 11)	Data	1	30H					
	Add	_	(DA)XXXH					
Program Suspend (Note12)	Data	1	ВОН					
	Add		(DA)XXXH					
Program Resume (Note11)	Data	1	30H					
5, 15, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1,	Add	-	XXX	XXX	ABP			
Block Protection/Unprotection (Note 13)	Data	3	60H	60H	60H			



Table 5. Command Sequences (Continued)

Command Definitions		Cycle	1st Cycle	2nd Cycle	3rd Cycle	4th Cycle	5th Cycle	6th Cycle
051.0 (\$1.1.4.4)	Add	4	(DA)X55H					
CFI Query (Note 14)	Data	1	98H					
Marita to Duffer (Nata 45)	Add	3	555H	2AAH	BA	BA	PA	WBL
Write to Buffer (Note 15)	Data	3	AAH	55H	25H	WC	PD	PD
	Add	4	BA					
Program buffer to Flash (Note 15)	Data	1	29H					
Maria ta B. Was Abasat Basat (Abata 40)	Add	3	555H	2AAH	XXX			
Write to Buffer Abort Reset (Note 16)	Data		AAH	55H	F0H			
Cat Durat Made Configuration Decistor (Nata 47)	Add	2	555H	2AAH	(CR)555H			
Set Burst Mode Configuration Register (Note 17)	Data	3	AAH	55H	C0H			
Forter OTD Disable Desires	Add	2	555H	2AAH	XXX			
Enter OTP Block Region	Data	3	AAH	55H	70H			
E 11 0 T D 1	Add	4	555H	2AAH	555H	XXX		
Exit OTP Block Region	Data	4	AAH	55H	75H	00H		

NOTE

- 1) RA: Read Address, PA: Program Address, RD: Read Data, PD: Program Data, BA: Block Address (A23 ~ A14), DA: Bank Address (A23 ~ A20) ABP: Address of the block to be protected or unprotected, DI:Die revision ID, CR: Configuration Register Setting, WBL: Write Buffer Location, WC: Word Count
- 2) The 4th cycle data of autoselect mode and RD are output data. The others are input data.
- 3) Data bits DQ15-DQ8 are don't care in command sequences, except for RD, PD and Device ID.
- 4) Unless otherwise noted, address bits A23-A11 are don't cares.
- 5) The reset command is required to return to read mode.
 - If a bank entered the autoselect mode during the erase suspend mode, writing the reset command returns that bank to the erase suspend mode. If a bank entered the autoselect mode during the program suspend mode, writing the reset command returns that bank to the program suspend mode. If DQ5 goes high during the program or erase operation, writing the reset command returns that bank to read mode or erase suspend mode if that bank was in erase suspend mode.
- 6) The 3rd and 4th cycle bank address of autoselect mode must be same.
- Device ID Data: "2206H" for Top Boot Block Device, "2207H" for Bottom Boot Block Device

 7) Normal Block Protection Verify: 00H for an unprotected block and 01H for a protected block.
- OTP Block Protect verify (with OTP Block Address after Entering OTP Block): 00H for unlocked, and 01H for locked. 8) 0H for handshaking, 1H for non-handshaking
- 9) The unlock bypass command sequence is required prior to this command sequence.
- 10) The system may read and program in non-erasing blocks when in the erase suspend mode.
 - The system may enter the autoselect mode when in the erase suspend mode.
- The erase suspend command is valid only during a block erase operation, and requires the bank address. 11) The erase/program resume command is valid only during the erase/program suspend mode, and requires the bank address.
- 12) This mode is used only to enable Data Read by suspending the Program operation.
- 13) Set ABP(Address of the block to be protected or unprotected) as either A6 = VIH, A1 = VIH and A0 = VIL for unprotected or A6 = VIL, A1 = VIH and A0 = VIL for protected.
- 14) Command is valid when the device is in Read mode or Autoselect mode.
- 15) For Buffer Program, Firstly Enter "Write to Buffer" Command sequence and then Enter Block Address and Word Count which is the number of word data will be programmed. Word Count is smaller than the number of data wanted to program by one, Example if 15 words are wanted to program then WC (Word Count) is 14. After Entering Command, Enter PA/PD's (Program Addresses/ Program Data). Finally Enter "Program buffer to Flash" Command sequence, This starts a buffer program operation. This Device supports 32 words Buffer Program. There is some caution points.
 - The number of PA/PD's which are entered must be same to WC+1
 - PA's which are entered must be same A23~A5 address bits because Buffer Address is A23~A5 address and decided by PA entered firstly.
 - If PA which are entered isn't same Buffer Address, then PA/PD which is entered may not be counted and not stored to Buffer.
 - Overwrite for program buffer is also prohibited.
- 16) Command sequence resets device for next command after aborted write-to-buffer operation
- 17) See "Set Burst Mode Configuration Register" for details.
- 18) On the third cycle, the data should be "C0h", address bits A10-A0 should be 101 0101 0101b, and address bits A18-A11 set the code to be latched.



DEVICE OPERATION

The device has inputs/outputs that accept both address and data information. To write a command or command sequence (which includes programming data to the device and erasing blocks of memory), the system must drive CLK, $\overline{\text{WE}}$ and $\overline{\text{CE}}$ to VIL and $\overline{\text{OE}}$ to VIH when writing commands or data.

The device provide the unlock bypass mode to save its program time for program operation. Unlike the standard program command sequence which is comprised of four bus cycles, only two program cycles are required to program a word in the unlock bypass mode. One block, multiple blocks, or the entire device can be erased. Table 3 indicates the address space that each block occupies. The device's address space is divided into sixteen banks: Bank 0 contains the boot/parameter blocks, and the other banks(from Bank 1 to 15) consist of uniform blocks. A "bank address" is the address bits required to uniquely select a bank. Similarly, a "block address" is the address bits required to uniquely select a block. Icc2 in the DC Characteristics table represents the active current specification for the write mode. The AC Characteristics section contains timing specification tables and timing diagrams for write operations.

Read Mode

The device automatically enters to asynchronous read mode after device power-up. No commands are required to retrieve data in asynchronous mode. After completing an Internal Program/Erase Routine, each bank is ready to read array data. The reset command is required to return a bank to the read(or erase-suspend-read)mode if DQ5 goes high during an active program/erase operation, or if the bank is in the autoselect mode.

The synchronous(burst) mode will *automatically* be enabled on the first rising edge on the CLK input while \overline{AVD} is held low. That means device enters from asynchronous read mode to burst read mode using CLK and \overline{AVD} signal. When the burst read is terminated, the device return to asynchronous read mode automatically.

Asynchronous Read Mode

For the asynchronous read mode a valid address should be asserted on A0-A23, while driving \overline{AVD} and \overline{CE} to Vil.. WE should remain at ViH. The data will appear on DQ0-DQ15. Since the memory array is divided into sixteen banks, each bank remains enabled for read access until the command register contents are altered.

Address access time (tAA) is equal to the delay from valid addresses to valid output data. The chip enable access time(tcE) is the delay from the falling edge of $\overline{\text{CE}}$ to valid data at the outputs. The output enable access time(toE) is the delay from the falling edge of $\overline{\text{OE}}$ to valid data at the output. To prevent the memory content from spurious altering during power transition, the initial state machine is set for reading array data upon device power-up, or after a hardware reset.

Synchronous (Burst) Read Mode

The device is capable of continuous linear burst operation and linear burst operation of a preset length. For the burst mode, the system should determine how many clock cycles are desired for the initial word(tIAA) of each burst access and what mode of burst operation is desired using "Burst Mode Configuration Register" command sequences. See "Set Burst Mode Configuration" for further details. The status data also can be read during burst read mode by using \overline{AVD} signal with a bank address which is programming or erasing. This status data by synchronous read mode can be output just once and then sychronous read mode will be terminated. To initiate the synchronous read again, a new address and \overline{AVD} pulse is needed after the host has completed status reads or the device has completed the program or erase operation. Note that, after power up, the device enters asynchronous read mode. A19 determine the synchronous burst read mode by setting '1'.

Continuous Linear Burst Read

The synchronous(burst) mode will *automatically* be enabled on the first rising edge on the CLK input while $\overline{\text{AVD}}$ is held low. Note that the device is enabled for asynchronous mode when it first powers up. The initial word is output that after the rising edge of the first CLK cycle. Subsequent words are output that after the rising edge of each successive clock cycle, which automatically increase the internal address counter. Note that the device has internal address boundary that occurs every 16 words. When the device is crossing the first word boundary, additional clock cycles are needed before data appears for the next address. The number of additional clock cycle can vary from zero to fourteen cycles, and the exact number of additional clock cycle depends on the starting address of burst read. The RDY output indicates this condition to the system by pulsing low. The device will continue to output sequential burst data, wrapping around to address 000000h after it reaches the highest addressable memory location until the system asserts $\overline{\text{CE}}$ high, $\overline{\text{RESET}}$ low or $\overline{\text{AVD}}$ low in conjunction with a new address.(See Table 4.) The reset command does not terminate the burst read operation.

If the host system crosses the bank boundary while reading in burst mode, and the accessed bank is not programming or erasing, a additional clock cycles are needed as previously mentioned. When it accesses the bank is programming or erasing, continuous burst read mode will be terminated after status data output once.

8-, 16-Word Linear Burst Read

As well as the Continuous Linear Burst Mode, there are two(8 & 16 word) linear wrap & no-wrap mode, in which a fixed number of words are read from consecutive addresses. In these modes, the addresses for burst read are determined by the group within which the starting address falls. The groups are sized according to the number of words read in a single burst sequence for a given mode. (See Table. 6)



Table 6. Burst Address Groups(Wrap mode)

Burst Mode	Group Size	Group Address Ranges
8 word	8 words	0-7h, 8-Fh, 10-17h,
16 word	16words	0-Fh, 10-1Fh, 20-2Fh,

As an example: In wrap mode case, if the starting address in the 8-word mode is 2h, the address range to be read would be 0-7h, and the wrap burst sequence would be 2-3-4-5-6-7-0-1h. The burst sequence begins with the starting address written to the device, but wraps back to the first address in the selected group. In a similar manner, 16-word wrap mode begin their burst sequence on the starting address written to the device, and then wrap back to the first address in the selected address group.

In no-wrap mode case, if the starting address in the 8-word mode is 2h, the no-wrap burst sequence would be 2-3-4-5-6-7-8-9h. The burst sequence begins with the starting address written to the device, and continue to the 8th address from starting address. In a similar manner, 16-word no-wrap mode begin their burst sequence on the starting address written to the device, and continue to the 16th address from starting address. Also, when the address cross the word boundary in no-wrap mode, same number of additional clock cycles as continuous linear mode is needed.

Programmable Wait State

The programmable wait state feature indicates to the device the number of additional clock cycles that must elapse after $\overline{\text{AVD}}$ is driven from low to high for burst read mode. Upon power up, the number of total initial access cycles defaults to fourteen.

Handshaking

The handshaking feature allows the host system to simply monitor the RDY signal from the device to determine when the initial word of burst data is ready to be read. To set the number of initial cycle for optimal burst mode, the host should use the programmable wait state configuration.(See "Set Burst Mode Configuration Register" for details.) The rising edge of RDY after \overline{OE} goes low indicates the initial word of valid burst data. Using the autoselect command sequence the handshaking feature may be verified in the device.

Set Burst Mode Configuration Register

The device uses a configuration register to set the various burst parameters: the number of initial cycles for burst and burst read mode. The burst mode configuration register must be set before the device enter burst mode.

The burst mode configuration register is loaded with a three-cycle command sequences. On the third cycle, the data should be C0h, address bits A10-A0 should be 101_0101_0101b, and address bits A18-A11 set the code to be latched. The device will power up or after a hardware reset with the default setting.

Table 7. Burst Mode Configuration Register Table

Address Bit	Function	Settings(Binary)
A19	Read Mode	1 = Synchronous Burst Read Mode 0 = Asynchronous Read Mode (default)
A18	RDY Active	1 = RDY active one clock cycle before data 0 = RDY active with data(default)
A17		000 = Continuous(default)
A16	Burst Read Mode	001 = 8-word linear with wrap 010 = 16-word linear with wrap
A15		011 = 8-word linear with no-wrap 100 = 16-word linear with no-wrap 101~111 = Reserve
A14		0000 = Data is valid on the 4th active CLK edge after AVD transition to ViH(40MHz)
A13	A13 A12 Programmable Wait State A11	0001 = Data is valid on the 5th active CLK edge after AVD transition to VIH(50MHz) 0010 = Data is valid on the 6th active CLK edge after AVD transition to VIH(54/60MHz)
A12		0011 = Data is valid on the 7th active CLK edge after AVD transition to V _{IH} (66/70MHz) 0100 = Data is valid on the 8th active CLK edge after AVD transition to V _{IH} (80MHz)
A11		1010 = Data is valid on the 9th active CLK edge after AVD transition to Viн(83/90MHz) 1011 = Data is valid on the 9th active CLK edge after AVD transition to Viн(100MHz) 1010 = Data is valid on the 10th active CLK edge after AVD transition to Viн(100MHz) 1011 = Data is valid on the 11th active CLK edge after AVD transition to Viн(108/110MHz) 1000 = Data is valid on the 12th active CLK edge after AVD transition to Viн(120MHz) 1001 = Data is valid on the 13th active CLK edge after AVD transition to Viн 1010 = Data is valid on the 14th active CLK edge after AVD transition to Viн(130MHz) 1011 = Data is valid on the 15th active CLK edge after AVD transition to Viн(130MHz) 1100~1111 = Reserve

Note

Initial wait state should be set according to it's clock frequency. Table7 recommend the program wait state for each clock frequencies. Not 100% tested



Programmable Wait State Configuration

This feature informs the device the number of clock cycles that must elapse after $\overline{\text{AVD}}$ is driven from low to high before data will be available. This value is determined by the input frequency of the device. Address bits A14-A11 determine the setting. (See Burst Mode Configuration Register Table) The Programmable wait state setting instructs the device to set a particular number of clock cycles for the initial access in burst mode. Note that hardware reset will set the wait state to the default setting, that is 14 initial cycles.

Burst Read Mode Setting

The device supports five different burst read modes: continuous linear mode, 8 and 16 word linear burst modes with wrap and 8 and 16 word linear burst modes with no-wrap.

RDY Configuration

By default, the RDY pin will be high whenever there is valid data on the output. The device can be set so that RDY goes active one data cycle before active data. Adddress bit A18 determines this setting. The RDY pin behaves same way in word boundary crossing case.

	Start	Burst Address Sequence(Decimal)			
	Addr.	Continuous Burst	8-word Burst	16-word Burst	
Wrap	0	0-1-2-3-4-5-6	0-1-2-3-4-5-6-7	0-1-2-3D-E-F	
	1	1-2-3-4-5-6-7	1-2-3-4-5-6-7-0	1-2-3-4E-F-0	
	2	2-3-4-5-6-7-8	2-3-4-5-6-7-0-1	2-3-4-5F-0-1	
	•	•	•		
	0	0-1-2-3-4-5-6	0-1-2-3-4-5-6-7	0-1-2-3D-E-F	
No-wrap					
	1	1-2-3-4-5-6-7	1-2-3-4-5-6-7-8	1-2-3-4E-F-10	
	2	2-3-4-5-6-7-8	2-3-4-5-6-7-8-9	2-3-4-5F-10-11	
				-	
		•	•	•	

Table 8. Burst Address Sequences

Autoselect Mode

By writing the autoselect command sequences to the system, the device enters the autoselect mode. This mode can be read only by asynchronous read mode. The system can then read autoselect codes from the internal register (which is separate from the memory array). Standard asynchronous read cycle timings apply in this mode. The device offers the Autoselect mode to identify manufacturer and device type by reading a binary code. In addition, this mode allows the host system to verify the block protection or unprotection. Table 5 shows the address and data requirements. The autoselect command sequence may be written to an address within a bank that is in the read mode, erase-suspend-read mode or program-suspend-read mode. The autoselect command may not be written while the device is actively programming or erasing in the device. The autoselect command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle that contains the address and the autoselect command. Note that the block address is needed for the verification of block protection. The system may read at any address within the same bank any number of times without initiating another autoselect command sequence. And the burst read should be prohibited during Autoselect Mode. To terminate the autoselect operation, write Reset command(F0H) into the command register.

 Description
 Address
 Read Data

 Manufacturer ID
 (DA) + 00H
 ECH

 Device ID
 (DA) + 01H
 2206H(Top Boot Block), 2207H(Bottom Boot Block)

 Block Protection/Unprotection
 (BA) + 02H
 01H (protected), 00H (unprotected)

 Handshaking
 (DA) + 03H
 0H : handshaking, 1H : non-handshaking

Table 9. Autoselect Mode Description

Standby Mode

When the $\overline{\text{CE}}$ inputs is held at $\text{Vcc} \pm 0.2\text{V}$, and the system is not reading or writing, the device enters $\overline{\text{Stand-by}}$ mode to minimize the power consumption. In this mode, the device outputs are placed in the high impedence state, independent of the $\overline{\text{OE}}$ input. When the device is in either of these standby modes, the device requires standard access time (tCE) for read access before it is ready to read data. If the device is deselected during erasure or programming, the device draws active current until the operation is completed. Iccs in the DC Characteristics



table represents the standby current specification.

Autosleep Mode

The device features Automatic Sleep Mode to minimize the device power consumption during both asynchronous and burst mode. When addresses remain stable for tAA+60ns, the device automatically enables this mode. The Automatic sleep mode is depends on the \overline{CE} , \overline{WE} and \overline{OE} signal, so \overline{CE} , \overline{WE} and \overline{OE} signals are held at any state. In a sleep mode, output data is latched and always available to the system. When \overline{OE} is active, the device provides new data without wait time. Automatic sleep mode current is equal to standby mode current.

Output Disable Mode

When the $\overline{\text{OE}}$ input is at V_{IH}, output from the device is disabled. The outputs are placed in the high impedance state.

Block Protection & Unprotection

To protect the block from accidental writes, the block protection/unprotection command sequence is used. On power up, all blocks in the device are protected. To unprotect a block, the system must write the block protection/unprotection command sequence. The first two cycles are written: addresses are don't care and data is 60h. Using the third cycle, the block address (ABP) and command (60h) is written, while specifying with addresses A6, A1 and A0 whether that block should be protected (A6 = VIL, A1 = VIH, A0 = VIL) or unprotected (A6 = VIH, A1 = VIH, A0 = VIL). After the third cycle, the system can continue to protect or unprotect additional cycles, or exit the sequence by writing F0h (reset command).

The device offers three types of data protection at the block level:

- The block protection/unprotection command sequence disables or re-enables both program and erase operations in any block.
- When WP is at VIL, the two outermost blocks are protected.
- When VPP is at VIL, all blocks are protected.

Note that user never float the Vpp and $\overline{\text{WP}}$, that is, Vpp is always connected with ViH, ViL or ViD and $\overline{\text{WP}}$ is ViH or ViL.

Hardware Reset

The device features a hardware method of resetting the device by the $\overline{\text{RESET}}$ input. When the $\overline{\text{RESET}}$ pin is held low(Vil) for at least a period of tRP, the device immediately terminates any operation in progress, tristates all outputs, and ignores all read/write commands for the duration of the $\overline{\text{RESET}}$ pulse. The device also resets the internal state machine to asynchronous read mode. To ensure data integrity, the interrupted operation should be reinitiated once the device is ready to accept another command sequence. The $\overline{\text{RESET}}$ pin may be tied to the system reset pin. If a system reset occurs during the Internal Program or Erase Routine, the device will be automatically reset to the asynchronous read mode; this will enable the systems microprocessor to read the boot-up firmware from the Flash memory. If $\overline{\text{RESET}}$ is asserted during a program or erase operation, the device requires a time of tREADY (during Internal Routines) before the device is ready to read data again. If $\overline{\text{RESET}}$ is asserted when a program or erase operation is not executing, the reset operation is completed within a time of tREADY (not during Internal Routines). tRH is needed to read data after $\overline{\text{RESET}}$ returns to Vih. Refer to the AC Characteristics tables for $\overline{\text{RESET}}$ parameters and to Figure 10 for the timing diagram. When $\overline{\text{RESET}}$ is at logic high, the device is in standard operation. When $\overline{\text{RESET}}$ transitions from logic-low to logic-high, the device resets all blocks to locked and defaults to the read array mode.

Software Reset

The reset command provides that the bank is reseted to read mode, erase-suspend-read mode or program-suspend-read mode. The addresses are in Don't Care state. The reset command may be written between the sequence cycles in an erase command sequence before erasing begins, or in an program command sequence before programming begins. If the device begins erasure or programming, the reset command is ignored until the operation is completed. If the program command sequence is written to a bank that is in the Erase Suspend mode, writing the reset command returns that bank to the erase-suspend-read mode. The reset command valid between the sequence cycles in an autoselect command sequence. In an autoselect mode, the reset command must be written to return to the read mode. If a bank entered the autoselect mode while in the Erase Suspend mode, writing the reset command returns that bank to the erase-suspend-read mode. Also, if a bank entered the autoselect mode while in the Program Suspend mode, writing the reset command returns that bank to the program-suspend-read mode. If DQ5 goes high during a program or erase operation, writing the reset command returns the banks to the read mode. (or erase-suspend-read mode if the bank was in Erase Suspend)

Program

The K8C54(55)15E can be programmed in units of a word. Programming is writing 0's into the memory array by executing the Internal Program Routine. In order to perform the Internal Program Routine, a four-cycle command sequence is necessary. The first two cycles are unlock cycles. The third cycle is assigned for the program setup command. In the last cycle, the address of the memory location and the data to be programmed at that location are written. The device automatically generates adequate program pulses and verifies the programmed cell margin by the Internal Program Routine. During the execution of the Routine, the system is not required to provide further controls or timings. During the Internal Program Routine, commands written to the device will be ignored.



Note that a hardware reset during a program operation will cause data corruption at the corresponding location.

Accelerated Program

The device provides accelerated program operations through the Vpp input. Using this mode, faster manufacturing throughput at the factory is possible. When VID is asserted on the Vpp input, the device automatically enters the Unlock Bypass mode, temporarily unprotects any protected blocks, and uses the higher voltage on the input to reduce the time required for program operations. In accelerated program mode, the system would use a two-cycle program command sequence for only a word program. By removing VID returns the device to normal operation mode.

Note that Read While Accelerated Program and Program suspend mode are not guaranteed.

- Program/Erase cycling must be limited below 100cycles for optimum performance.
- Ambient temperature requirements : T_A = 30°C±10°C

Write Buffer Programming

Write Buffer Programming allows the system write to a maximum of 32 words in one programming operation. This results in faster effective programming time than the standard programming algorithms. The Write Buffer Programming command sequence is initi-ated by first writing two unlock cycles. This is followed by a third write cycle containing the Write Buffer Load command written at the block address in which programming will occur. The fourth cycle writes the block address and the number of word locations, minus one, to be programmed. For example, if the system will program 19 unique address locations, then 12h should be written to the device. This tells the device how many write buffer addresses will be loaded with data. The number of locations to program cannot exceed the size of the write buffer or the operation will abort. The fifth cycle writes the first address location and data to be programmed. The write-buffer-page is selected by address bits A23(max.) ~ A5 entered at fifth cycle. All subsequent address/ data pairs must fall within the selected write-buffer-page, so that all subsequent addresses must have the same address bit A23(max.) ~ A5 as those entered at fifth cycle. Write buffer locations may be loaded in any order.

Once the specified number of write buffer locations have been loaded, the system must then write the "Program Buffer to Flash" com mand at the block address. Any other command address/data combination aborts the Write Buffer Programming operation. The device then begins programming. Data polling should be used while monitoring the last address location loaded into the write buffer. DQ7, DQ6, DQ5, and DQ1 should be monitored to determine the device status during Write Buffer Programming. The write-buffer programming operation can be suspended using the standard program suspend/resume commands. Upon successful completion of the Write Buffer Programming operation, the device is ready to execute the next command. Note also that an address loaction cannot be loaded more than once into the write-buffer-page.

The Write Buffer Programming Sequence can be aborted in the following ways:

- Loading a value that is greater than the buffer size(32-words) during then number of word locations to Program step. (In case, WC > 1FH @Table5)
- The number of Program address/data pairs entered is different to the number of word locations initially defined with WC (@Table5)
- Writing a Program address to have a different write-buffer-page with selected write-buffer-page (Address bits A23(max) ~ A5 are different)
- Writing non-exact "Program Buffer to Flash" command

The abort condition is indicated by DQ1 = 1, DQ7 = DATA (for the last address location loaded), DQ6 = toggle, and DQ5=0. A "Write-to-Buffer-Abort Reset" command sequence must be written to reset the device for the next operation. Note that the third cycle of Write-to-Buffer-Abort Reset command sequence is required when using Write-Buffer-Programming features in Unlock Bypass mode. And from the third cycle to the last cycle of Write to Buffer command is also required when using Write-Buffer-Programming features in Unlock Bypass mode. A bit cannot be programmed from "0" back to a "1." Attempting to do so may cause the device to set DQ5 = 1, or cause the DQ7 and DQ6 status bits to indicate the operation was successful. However, a succeeding read will show that the data is still "0." Only erase operations can convert a "0" to a "1."

Accelerated Write Buffer Programming

The device provides accelerated Write Buffer Program operations through the Vpp input. Using this mode, faster manufacturing throughput at the factory is possible. When Vid is asserted on the Vpp input, the device temporarily unprotects any protected blocks, and uses the higher voltage on the input to reduce the time required for program operations. In accelerated Write Buffer Program mode, the system must enter "Write to Buffer" and "Program Buffer to Flash" command sequence to be same as them of normal Write Buffer Programming and only can reduce the program time. Note that the third cycle of "Write to Buffer Abort Reset" command sequence is required in an Accelerated mode. Note that Read While Accelerated Write Buffer Program and Program suspend mode are not guaranteed.

- Program/Erase cycling must be limited below 100cycles for optimum performance.
- Ambient temperature requirements : T_A = 30°C±10°C



Chip Erase

To erase a chip is to write 1's into the entire memory array by executing the Internal Erase Routine. The Chip Erase requires six bus cycles to write the command sequence. The erase set-up command is written after first two "unlock" cycles. Then, there are two more write cycles prior to writing the chip erase command. The Internal Erase Routine automatically pre-programs and verifies the entire memory for an all zero data pattern prior to erasing. The automatic erase begins on the rising edge of the last $\overline{\text{WE}}$ pulse in the command sequence and terminates when DQ7 is "1". After that the device returns to the read mode.

Block Erase

To erase a block is to write 1's into the desired memory block by executing the Internal Erase Routine. The Block Erase requires six bus cycles to write the command sequence shown in Table 5. After the first two "unlock" cycles, the erase setup command (80H) is written at the third cycle. Then there are two more "unlock" cycles followed by the Block Erase command. The Internal Erase Routine automatically pre-programs and verifies the entire memory prior to erasing it. The block address is latched on the rising edge of $\overline{\text{AVD}}$, while the Block Erase command is latched on the rising edge of $\overline{\text{WE}}$. Multiple blocks can be erased sequentially by writing the sixth bus-cycle. Upon completion of the last cycle for the Block Erase, additional block address and the Block Erase command (30H) can be written to perform the Multi-Block Erase. For the Multi-Block Erase, only sixth cycle(block address and 30H) is needed.(Similarly, only second cycle is needed in unlock bypass block erase.) An 50us (typical) "time window" is required between the Block Erase command writes. The Block Erase command must be written within the 50us "time window", otherwise the Block Erase command will be ignored. The 50us "time window" is reset when the falling edge of the WE occurs within the 50us of "time window" to latch the Block Erase command. During the 50us of "time window", any command other than the Block Erase or the Erase Suspend command written to the device will reset the device to read mode. After the 50 us of "time window", the Block Erase command will initiate the Internal Erase Routine to erase the selected blocks. Any Block Erase address and command following the exceeded "time window" may or may not be accepted. No other commands will be recognized except the Erase Suspend command during Block Erase operation.

Unlock Bypass

The K8C54(55)15E provides the unlock bypass mode to save its operation time. This mode is possible for program, block erase and chip erase operation. There are two methods to enter the unlock bypass mode. The mode is invoked by the unlock bypass command sequence or the assertion of VID on VPP pin. Unlike the standard program/erase command sequence that contains four bus cycles, the unlock bypass program/erase command sequence comprises only two bus cycles. The unlock bypass mode is engaged by issuing the unlock bypass command sequence which is comprised of three bus cycles. Writing first two unlock cycles is followed by a third cycle containing the unlock bypass command (20H). Once the device is in the unlock bypass mode, the unlock bypass program/erase command sequence is necessary. The unlock bypass program command sequence is comprised of only two bus cycles; writing the unlock bypass program command (A0H) is followed by the program address and data. This command sequence is the only valid one for programming the device in the unlock bypass mode. Also, The unlock bypass erase command sequence is comprised of two bus cycles; writing the unlock bypass block erase command(80H-30H) or writing the unlock bypass chip erase command(80H-10H). This command sequences are the only valid ones for erasing the device in the unlock bypass mode. The unlock bypass reset command sequence consists of two bus cycles. The first cycle must contain the data (90H). The second cycle contains only the data (00H). Then, the device returns to the read mode.

To enter the unlock bypass mode in hardware level, the VID also can be used. By assertion VID on the VPP pin, the device enters the unlock bypass mode. Also, the all blocks are temporarily unprotected when the device using the VID for unlock bypass mode. To exit the unlock bypass mode, just remove the asserted VID from the VPP pin. (Note that user never float the Vpp, that is, Vpp is always connected with VIH, VIL or VID.).

Erase Suspend / Resume

The Erase Suspend command interrupts the Block Erase to read or program data in a block that is not being erased. Also, it is possible to protect or unprotect of the block that is not being erased in erase suspend mode. The Erase Suspend command is only valid during the Block Erase operation including the time window of 50 us. The Erase Suspend command is not valid while the Chip Erase or the Internal Program Routine sequence is running. When the Erase Suspend command is written during a Block Erase operation, the device requires a maximum of 20 us(recovery time) to suspend the erase operation. Therefore system must wait for 20us(recovery time) to read the data from the bank which include the block being erased. Otherwise, system can read the data immediately from a bank which don't include the block being erased without recovery time(max. 20us) after Erase Suspend command. And, after the maximum 20us recovery time, the device is availble for programming data in a block that is not being erased. But, when the Erase Suspend command is written during the block erase time window (50 us), the device immediately terminates the block erase time window and suspends the erase operation. The system may also write the autoselect command sequence when the device is in the Erase Suspend mode. When the Erase Resume command is executed, the Block Erase operation will resume. When the Erase Suspend or Erase Resume command is executed, the addresses are in Don't Care state. In erase suspend followed by resume operation, min. 200ns is needed for checking the busy status.



Program Suspend / Resume

The device provides the Program Suspend/Resume mode. This mode is used to enable Data Read by suspending the Program operation. The device accepts a Program Suspend command in Program mode(including Program operations performed during Erase Suspend) but other commands are ignored. After input of the Program Suspend command, 5us is needed to enter the Program Suspend Read mode. Therefore system must wait for 5us(recovery time) to read the data from the bank which include the block being programmed. Othwewise, system can read the data immediately from a bank which don't include block being programmed without ecovery time(max. 5us) after Program Suspen command. Like an Erase Suspend mode, the device can be returned to Program mode by using a Program Resume command. In the program suspend mode, protect/unprotect command is prohibited. In program suspend followed by resume operation, min. 200ns is needed for checking the busy status.

Read While Write Operation

The device is capable of reading data from one bank while writing in the other banks. This is so called the Read While Write operation. An erase operation may also be suspended to read from or program to another location within the same bank(except the block being erased). The Read While Write operation is prohibited during the chip erase operation. Figure 17 shows how read and write cycles may be initiated for simultaneous operation with zero latency. Refer to the DC Characteristics table for read-while-write current specifications.

OTP Block Region

The OTP Block feature provides a 512-word Flash memory region that enables permanent part identification through an Electronic Serial Number (ESN). The OTP Block is customer lockable and shipped with itself unlocked, allowing customers to untilize the that block in any manner they choose. The customer-lockable OTP Block has the Protection Verify Bit (DQ0) set to a "0" for Unlocked state or a "1" for Locked state. The system accesses the OTP Block through a command sequence (see "Enter OTP Block / Exit OTP Block Command sequence" at Table8). After the system has written the "Enter OTP Block" Command sequence, it may read the OTP Block by using the addresses (FFFF80h~FFFFFh) normally and may check the Protection Verify Bit (DQ0) by using the "Autoselect Block Protection Verify" Command sequence with OTP Block address. This mode of operation continues until the system issues the "Exit OTP Block" Command suquence, a hardware reset or until power is removed from the device. On power-up, or following a hardware reset, the device reverts to sending commands to main blocks. Note that the Accelerated function and unlock bypass modes are not available when the OTP Block is enabled.

Customer Lockable

In a Customer lockable device, The OTP Block is one-time programmable and can be locked only once. Note that the Accelerated programming and Unlock bypass functions are not available when programming the OTP Block. Locking operation to the OTP Block is started by writing the "Enter OTP Block" Command sequence, and then the "Block Protection" Command sequence (Table 5) with an OTP Block address. The Locking operation has to be above 100us. "Exit OTP Block" command sequence and Hardware reset makes locking operation finished and then exiting from OTP Block after 30us.

The OTP Block Lock operation must be used with caution since, once locked, there is no procedure available for unlocking and none of the bits in the OTP Block space can be modified in any way.

Suspend and resume operation are not supported during OTP protect, nor is OTP protect supported during any suspend operations

Low Vcc Write Inhibit

To avoid initiation of a write cycle during Vcc power-up and power-down, a write cycle is locked out for Vcc less than VLKO. If the Vcc < VLKO (Lock-Out Voltage), the command register and all internal program/erase circuits are disabled. Under this condition the device will reset itself to the read mode. Subsequent writes will be ignored until the Vcc level is greater than VLKO. It is the user's responsibility to ensure that the control pins are logically correct to prevent unintentional writes when Vcc is above VLKO.

Write Pulse "Glitch" Protection

Noise pulses of less than 5ns (typical) on \overline{OE} , \overline{CE} , \overline{AVD} or \overline{WE} do not initiate a write cycle.

Logical Inhibit

Write cycles are inhibited by holding any one of $\overline{OE} = V_{IL}$, $\overline{CE} = V_{IH}$ or $\overline{WE} = V_{IH}$. To initiate a write cycle, \overline{CE} and \overline{WE} must be a logical zero while \overline{OE} is a logical one.

Deep Power Down

In order to reduce the power consumption of the device, it shall a deep power down mode inplemented on a seperate pin. The deep power down mode is active when the deep power down signal is activated, high state. In deep power down the device shall turn off all circuitry in order to reach a power consumption of 2uA(Tpy). The device shall exit the deep power down mode within 70us after that the deep power



down signal has been de-activated, set to low. In deep power down the state of the device chip select shall have no impact on the device power consumption. All programming capabilities of the device are inhibited.

At the power up, the device shall accept any order of activation of the reset and deep power down signal. The device shall respond within the specified time for the signal that was deactivated/activated latest. The deep power down mode is activated when DPD pin high state only. If DPD is asserted during a program or erase operation, the device requires a time of tDP(During Internal Routines) before the device is ready to enter DPD mode.

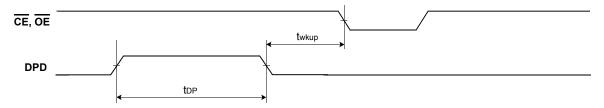
Deep Power Down (DPD)

Parameter	Symbol	All Speed Options			Unit
Farameter		Min	Тур	Max	Offic
DPD Pin High(NOT During Internal Routines) to DPD Mode (Note)	top	100	-	-	ns
DPD Pin High(During Internal Routines) to DPD Mode (Note)	top	20	-	-	μ\$
DPD Low Time Before Read (Note)	twkup	75	-	-	μS

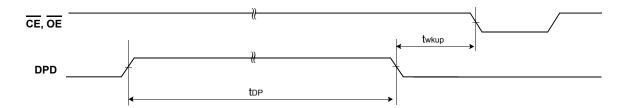
NOTE

Not 100% tested.

SWITCHING WAVEFORMS



Reset Timings NOT during Internal Routines



Reset Timings during Internal Routines

Figure 1. DPD Timings



FLASH MEMORY STATUS FLAGS

The K8C54(55)15E has means to indicate its status of operation in the bank where a program or erase operation is in processes. Address must include bank address being executed internal routine operation. The status is indicated by raising the device status flag via corresponding DQ pins. The status data can be read during burst read mode by using $\overline{\text{AVD}}$ signal with a bank address. That means status read is supported in synchronous mode. If status read is performed, the data provided in the burst read is identical to the data in the initial access. To initiate the synchronous read again, a new address and $\overline{\text{AVD}}$ pulse is needed after the host has completed status reads or the device has completed the program or erase operation. The corresponding DQ pins are DQ7, DQ6, DQ5, DQ3, DQ2 and DQ1.

Status DQ7 DQ6 DQ5 DQ3 DQ2 DQ1 DQ7 Programming Toggle 0 0 0 Block Erase or Chip Erase 0 Toggle 0 1 0 Toggle Erase Suspended Toggle 1 1 0 0 0 Erase Suspend Read Block (Note 1) Non-Erase Suspended Data Data Data Data Data Data Erase Suspend Read Block In Progress Erase Suspend Non-Erase Suspended DQ7 Toggle 0 0 1 0 Program Block Program Suspended Toggle Program Suspend Read DQ7 1 0 0 0 Block (Note 1) Non- program Program Suspend Read Data Data Data Data Data Data Suspended Block DQ7 0 No Toggle O Programming Toggle 1 Exceeded Block Erase or Chip Erase Toggle 1 1 (Note 2) n n Time Limits DQ7 1 0 0 Erase Suspend Program No Toggle Toggle **BUSY** state DQ7 0 0 No Toggle 0 Toggle Write-to-**Exceeded Timing Limits** DQ7 1 0 No Toggle 0 Buffer Toggle (Note3) ABORT State DQ7 O 0 No Toggle 1 Toggle

Table 10. Hardware Sequence Flags

NOTE

- 1) DQ2 will toggle when the device performs successive read operations from the erase/program suspended block.
- 2) If DQ5 is High (exceeded timing limits), successive reads from a problem block will cause DQ2 to toggle.
- 3) Note that DQ7 during Write-to-Buffer-Programming indicates the data-bar for DQ7 data for the last loaded write-buffer address location.

DQ7: Data Polling

When an attempt to read the device is made while executing the Internal Program, the complement of the data is written to DQ7 as an indication of the Routine in progress. When the Routine is completed an attempt to access to the device will produce the true data written to DQ7. When a user attempts to read the block being erased, DQ7 will be low. If the device is placed in the Erase/Program Suspend Mode, the status can be detected via the DQ7 pin. If the system tries to read an address which belongs to a block that is being erase suspended, DQ7 will be high. And, if the system tries to read an address which belongs to a block that is being program suspended, the output will be the true data of DQ7 itself. If a non-erase-suspended or non-program-suspended block address is read, the device will produce the true data to DQ7. If an attempt is made to program a protected block, DQ7 outputs complements the data for approximately 1µs and the device then returns to the Read Mode without changing data in the block. If an attempt is made to erase a protected block, DQ7 outputs complement data in approximately 100us and the device then returns to the Read Mode without erasing the data in the block.

DQ6: Toggle Bit

Toggle bit is another option to detect whether an Internal Routine is in progress or completed. Once the device is at a busy state, DQ6 will toggle. Toggling DQ6 will stop after the device completes its Internal Routine. If the device is in the Erase/Program Suspend Mode, an attempt to read an address that belongs to a block that is being erased or programmed will produce a high output of DQ6. If an address belongs to a block that is not being erased or programmed, toggling is halted and valid data is produced at DQ6. If an attempt is made to program a protected block, DQ6 toggles for approximately 1us and the device then returns to the Read Mode without changing the data in the block. If an attempt is made to erase a protected block, DQ6 toggles for approximately 100µs and the device then returns to the Read Mode without erasing the data in the block.

DQ5: Exceed Timing Limits

If the Internal Program/Erase Routine extends beyond the timing limits, DQ5 will go High, indicating program/erase failure.



DQ3: Block Erase Timer

The status of the multi-block erase operation can be detected via the DQ3 pin. DQ3 will go High if $50\mu s$ of the block erase time window expires. In this case, the Internal Erase Routine will initiate the erase operation. Therefore, the device will not accept further write commands until the erase operation is completed. DQ3 is Low if the block erase time window is not expired. Within the block erase time window, an additional block erase command (30H) can be accepted. To confirm that the block erase command has been accepted, the software may check the status of DQ3 following each block erase command.

DQ2: Toggle Bit 2

The device generates a toggling pulse in DQ2 only if an Internal Erase Routine or an Erase/Program Suspend is in progress. When the device executes the Internal Erase Routine, DQ2 toggles only if an erasing block is read. Although the Internal Erase Routine is in the Exceeded Time Limits, DQ2 toggles only if an erasing block in the Exceeded Time Limits is read. When the device is in the Erase/Program Suspend mode, DQ2 toggles only if an address in the erasing or programming block is read. If a non-erasing or non-programmed block address is read during the Erase/Program Suspend mode, then DQ2 will produce valid data. DQ2 will go High if the user tries to program a non-erase suspend block while the device is in the Erase Suspend mode.

DQ1: Buffer Program Abort Indicator

DQ1 indocates whether a Write-to-Buffer operation was aborted. Under these conditions DQ1 produces a "1". The system must issue the Write-to-Buffer-Abort-Reset command sequence to return the device to reading array data.

RDY: Ready

Normally the RDY signal is used to indicate if new burst data is available at the rising edge of the clock cycle or not. If RDY is low state, data is not valid at expected time, and if high state, data is valid. Note that, if \overline{CE} is low and \overline{OE} is high, the RDY is high state.

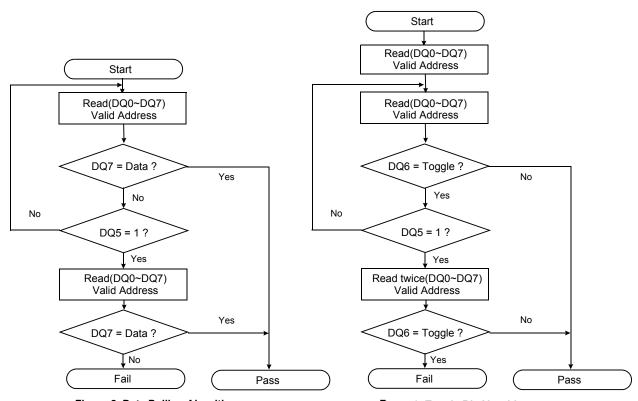


Figure 2. Data Polling Algorithms

Figure 3. Toggle Bit Algorithms



Commom Flash Memory Interface

Common Flash Momory Interface is contrived to increase the compatibility of host system software. It provides the specific information of the device, such as memory size and electrical features. Once this information has been obtained, the system software will know which command sets to use to enable flash writes, block erases, and control the flash component.

When the system writes the CFI command(98H) to address 55H, the device enters the CFI mode. And then if the system writes the address shown in Table 11, the system can read the CFI data. Query data are always presented on the lowest-order data outputs(DQ0-7) only. In word(x16) mode, the upper data outputs(DQ8-15) is 00h. To terminate this operation, the system must write the reset command.

Table 11. Common Flash Memory Interface Code

Description	Addresses (Word Mode)	Data	
	10H	0051H	
Query Unique ASCII string "QRY"	11H	0052H	
	12H	0059H	
Primary OEM Command Set	13H 14H	0002H	
·		0000H	
Address for Primary Extended Table	15H 16H	0040H 0000H	
	17H	0000H	
Alternate OEM Command Set (00h = none exists)	1711 18H	0000H	
	19H	0000H	
Address for Alternate OEM Extended Table (00h = none exists)	1AH	0000H	
Vcc Min. (write/erase)	4011	004711	
D7-D4: volt, D3-D0: 100 millivolt	1BH	0017H	
Vcc Max. (write/erase)	1CH	0019H	
D7-D4: volt, D3-D0: 100 millivolt	1011	001311	
Vpp(Acceleration Program) Supply Minimum	4511	000=11	
00 = Not Supported, D7 - D4 : Volt, D3 - D0 : 100mV	1DH	0085H	
Vpp(Acceleration Program) Supply Maximum			
00 = Not Supported, D7 - D4 : Volt, D3 - D0 : 100mV	1EH	0095H	
Typical timeout per single word write 2 ^N us	1FH	0008H	
Typical timeout for Max buffer write 2 ^N us(00H = not supported)	20H	0009H	
Typical timeout per individual block erase 2 ^N ms	21H	000AH	
Typical timeout for full chip erase 2 ^N ms(00H = not supported)	22H	0012H	
Max. timeout for word write 2 ^N times typical	23H	0001H	
Max. timeout for buffer write 2 ^N times typical	24H	0001H	
Max. timeout per individual block erase 2 ^N times typical	25H	0004H	
Max. timeout for full chip erase 2 ^N times typical(00H = not supported)	26H	0000H	
Device Size = 2 ^N byte	27H	0019H	
Flash Device Interface description	28H	0000H	
i iasii Device iiileiiace descriptiori	29H	0000H	
Max. number of byte in multi-byte write = 2 ^N	2AH	0006H	
<u> </u>	2BH	0000H	
Number of Erase Block Regions within device	2CH	0002H	



Table 11. Common Flash Memory Interface Code (Continued)

Description	Addresses (Word Mode)	Data
Erase Block Region 1 Information Bits 0~15: y+1=block number Bits 16~31: block size= z x 256bytes	2DH 2EH 2FH	0003Н 0000Н 0080Н
DIG 10 01. Block 3/20 - 2 x 200byte3	30H	0000H
Erase Block Region 2 Information	31H 32H 33H 34H	00FEH 0000H 0000H 0002H
Erase Block Region 3 Information	35H 36H 37H 38H	0000Н 0000Н 0000Н 0000Н
Erase Block Region 4 Information	39H 3AH 3BH 3CH	0000H 0000H 0000H 0000H
Query-unique ASCII string "PRI"	40H 41H 42H	0050H 0052H 0049H
Major version number, ASCII	43H	0030H
Minor version number, ASCII	44H	0030H
Address Sensitive Unlock(Bits 1-0) 0 = Required, 1= Not Required Silcon Revision Number(Bits 7-2)	45H	0000Н
Erase Suspend 0 = Not Supported, 1 = To Read Only, 2 = To Read & Write	46H	0002H
Block Protect 00 = Not Supported, 01 = Supported	47H	0001H
Block Temporary Unprotect 00 = Not Supported, 01 = Supported	48H	0000H
Block Protect/Unprotect scheme 00 = Not Supported, 01 = Supported	49H	0001H
Simultaneous Operation 00 = Not Supported, 01 = Supported	4AH	0001H
Burst Mode Type 00 = Not Supported, 01 = Supported	4BH	0001H
Page Mode Type 00 = Not Supported, 01 = 4 Word Page 02 = 8 Word Page	4CH	0000H
Top/Bottom Boot Block Flag 02H = Bottom Boot Device, 03H = Top Boot Device	4DH	0003H
Max. Operating Clock Frequency (MHz)*	4EH	0085H
RWW(Read While Write) Functionality Restriction (00H = non exists , 01H = exists)	4FH	0000H
Handshaking 00 = Not Supported at both mode, 01 = Supported at Sync. Mode 10 = Supported at Async. Mode, 11 = Supported at both Mode	50H	0001H

^{*} Max. Operating Clock Frequency : Data is 53H in 66/83Mhz part (K8C5415ET(B)M)



ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Rating	Unit
	Vcc	Vcc	-0.5 to +2.5	
Voltage on any pin relative to Vss	VPP	Vin	-0.5 to +9.5	V
	All Other Pins	VIIN	-0.5 to +2.5	
Tomporatura Under Dice	Commercial	Thias	-10 to +125	°C
Temperature Under Bias	Extended	I bias	-25 to +125	-0
Storage Temperature		Tstg	-65 to +150	°C
Short Circuit Output Current	Short Circuit Output Current		5	mA
Operating Temperature		Ta (Commercial Temp.)	0 to +70	°C
Operating Temperature		TA (Extended Temp.)	-25 to + 85	°C



¹⁾ Minimum DC voltage is -0.5V on Input/ Output pins. During transitions, this level may fall to -2.0V for periods <20ns. Maximum DC voltage is Vcc+0.6V on input / output pins which, during transitions, may overshoot to Vcc+2.0V for periods <20ns.

²⁾ Minimum DC input voltage is -0.5V on VPP During transitions, this level may fall to -2.0V for periods <20ns.

Maximum DC input voltage is +9.5V on VPP which, during transitions, may overshoot to +12.0V for periods <20ns.

3) Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to the conditions detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

RECOMMENDED OPERATING CONDITIONS (Voltage reference to GND)

Parameter	Symbol	Min	Тур.	Max	Unit
Supply Voltage	Vcc	1.7	1.8	1.95	V
Supply Voltage	Vss	0	0	0	V

DC CHRACTERISTICS

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
Input Leakage Current	lu	VIN=Vss to Vcc, Vcc=Vccmax		- 1.0	-	+ 1.0	μА
VPP Leakage Current	ILIP	VCC=VCCmax , VPP=9.5V		-	-	35	μΑ
Output Leakage Current	llo	VOUT=VSS to VCC, VCC=VCCmax	, OE=Vih	- 1.0	-	+ 1.0	μΑ
Active Burst Read Current	Іссв1	CE=VIL, OE=VIH (@133MHz)		-	35	55	mA
Active Asynchronous	loga	CE=VIL, OE=VIH	10MHz	-	35	55	mA
Read Current	Icc1	CE=VIL, OE=VIH	1MHz	-	8	10	mA
Active Write Current (Note 2)	Icc2	CE=VIL, OE=VIH, WE=VIL, VPP=	=VIH	-	25	40	mA
Read While Write Current	Icc3	CE=VIL, OE=VIH		-	45	70	mA
Accelerated Program Current	ICC4	CE=VIL, OE=VIH, VPP=9.5V		-	20	30	mA
Standby Current	ICC5	CE= RESET=Vcc ± 0.2V		-	30	110	μА
Standby Current During Reset	Icc6	RESET = Vss ± 0.2V		-	30	110	μА
Automatic Sleep Mode(Note 3)	Icc7	*	CE=Vss ± 0.2V, Other Pins=V _{IL} or V _{IH} V _{IL} = Vss ± 0.2V, V _{IH} = V _{CC} ± 0.2V		30	110	μА
Deep Power Down Mode	Icc8			-	2	20	μА
Input Low Voltage	VIL			-0.5	-	0.4	V
Input High Voltage	VIH			Vcc-0.4	-	Vcc+0.4	V
Output Low Voltage	Vol	IOL = 100 μA , VCC=VCCmin		-	-	0.1	V
Output High Voltage	Vон	IOH = -100 μA , VCC=VCCmin		Vcc-0.1	-	-	V
Voltage for Accelerated Program	VID			8.5	9.0	9.5	V
Low Vcc Lock-out Voltage	VLKO			1.0	-	-	V
Van ourrent in program/orass	lumn	Vpp = 9.5V		-	0.8	5	mA
Vpp current in program/erase	lvpp	Vpp = 1.95V	-	-	50	μА	

NOTE

1) Maximum ICC specifications are tested with VCC = VCCmax.
2) ICC active while Internal Erase or Internal Program is in progress.
3) Device enters automatic sleep mode when addresses are stable for tAA + 60ns.

CAPACITANCE($T_A = 25$ °C, $V_{CC} = 1.8V$, f = 1.0MHz)

Item	Symbol	Test Condition	Min	Max	Unit
Input Capacitance	Cin	VIN=0V	-	4	pF
Output Capacitance	Соит	Vout=0V	-	6	pF
Control Pin Capacitance	CIN2	V _{IN} =0V	-	4	pF

Capacitance is periodically sampled and not 100% tested.

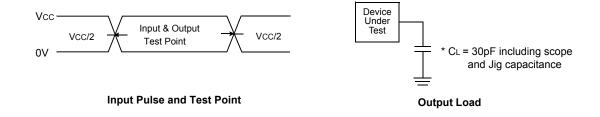


AC TEST CONDITION

Parameter	Value
Input Pulse Levels	0V to Vcc
Input Rise and Fall Times	1ns*
Input and Output Timing Levels	Vcc/2
Output Load	CL = 30pF

NOTE

If clock rising time is longer than 1ns, (tr/2-0.5)ns should be added to the parameter. Assumed input rise and fall time (tr & tf) = 1ns. If tr & tf is longer than 1ns, transient time compensation should be considered,i.e., [(tr + tf)/2-1]ns should be added to the parameter.



AC CHARACTERISTICS

Synchronous/Burst Read

Parameter	Symbol	_	IC MHz)	_	D VIHz)	_	E MHz)		1F MHz)	Unit
		Min	Max	Min	Max	Min	Max	Min	Max	
Initial Access Time	tiaa	-	100	-	100	-	100	-	100	ns
Burst Access Time Valid Clock to Output Delay	tBA	-	11	-	9	-	7	-	6	ns
AVD Setup Time to CLK	tavds	5	-	4	-	4	-	2.5	-	ns
AVD Hold Time from CLK	tavdh	2	-	2	-	2	-	2	-	ns
Address Setup Time to CLK	tacs	5	-	4	-	4	-	2.5	-	ns
Address Hold Time from CLK	tach	6	-	5	-	2	-	2	-	ns
Data Hold Time from Next Clock Cycle	tврн	4	-	4	-	3	-	3	-	ns
Output Enable to RDY valid	toer	-	11	-	9	-	7	-	6	ns
CE Disable to High Z	tcez	-	15	-	15	-	15	-	15	ns
OE Disable to High Z	toez	-	15	-	15	-	15	-	15	ns
CE Setup Time to CLK	tces	4.5	-	4.5	-	4.5	-	4.5	-	ns
CLK to RDY Setup Time	trdya	-	11	-	9	-	7	-	6	ns
RDY Setup Time to CLK	trdys	3	-	3	-	2	-	2	-	ns
CLK High or Low Time	tclkh/L	3.5	-	3	-	2.5	-	2.5	-	ns
CLK Fall or Rise Time	tclkHcl	-	3	-	3	-	2	-	1	ns

NOTE

Not 100% tested.



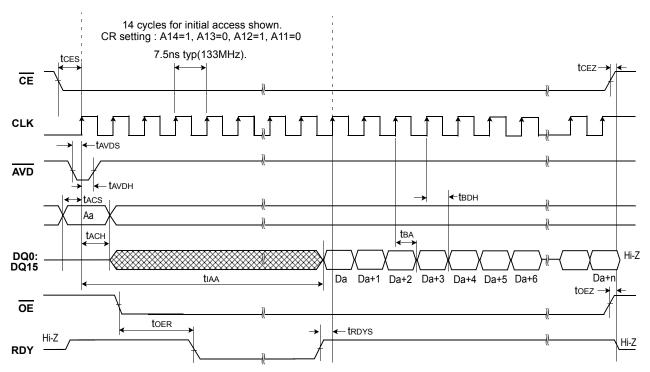


Figure 4. Continuous Burst Mode Read (133 MHz)

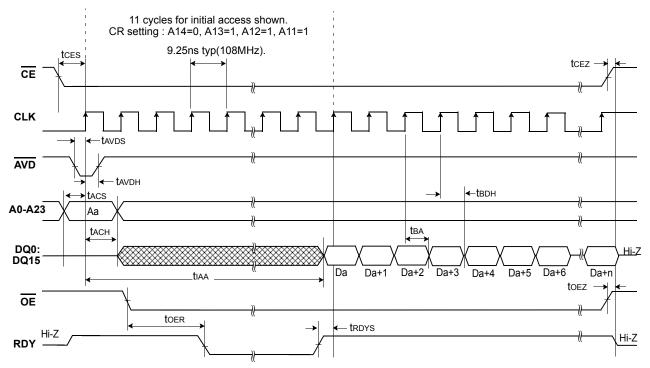


Figure 5. Continuous Burst Mode Read (108 MHz)



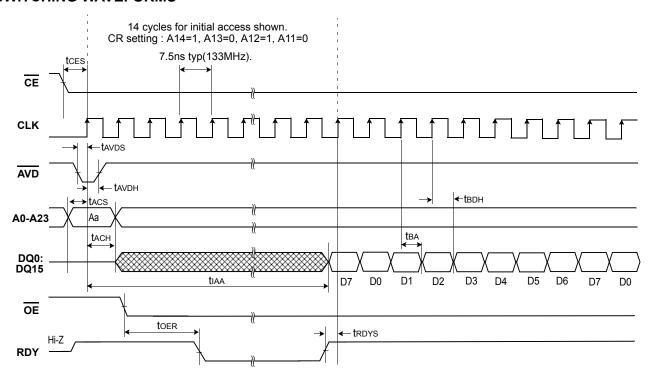


Figure 6. 8 word Linear Burst Mode with Wrap Around (133 MHz)

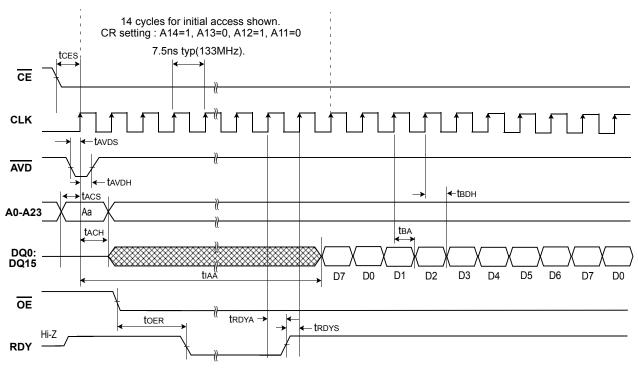


Figure 7. 8 word Linear Burst with RDY Set One Cycle Before Data (Wrap Around Mode, CR setting: A18=1)



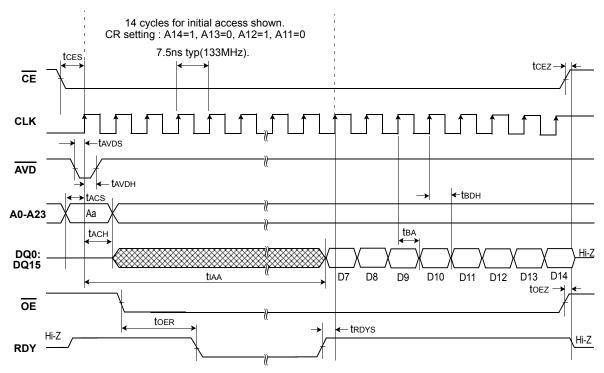


Figure 8. 8 word Linear Burst Mode (No Wrap Case)

AC CHARACTERISTICS

Asynchronous Read

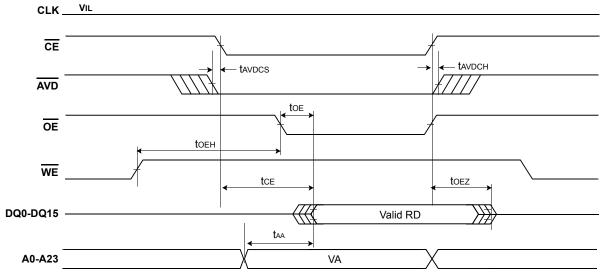
Parameter		Symbol	All Speed option			
Para	Faranieter		Min	Max	Unit	
Access Time from CE Low	1	tce	-	100	ns	
Asynchronous Access Time		taa	-	100	ns	
AVD Low Setup Time to CE Enable		tavdcs	0	-	ns	
AVD Low Hold Time from	AVD Low Hold Time from CE Disable		0	-	ns	
Output Enable to Output V	/alid	toe	-	15	ns	
Output Enable Hold	Read	toru	0	-	ns	
Time	Toggle and Data Polling	toeh	10	-	ns	
Output Disable to High Z(I	Note)	toez	-	15	ns	

NOTE

Not 100% tested.



SWITCHING WAVEFORMS Asynchronous Mode Read



NOTE

<u>VA=V</u>alid Read Address, RD=Read Data.

AVD should be held V_{IL} in asynchronous read mode.

Asynchronous mode may not support read following four sequential invalid read condition within 200ns.

Figure 9. Asynchronous Mode Read

AC CHARACTERISTICS

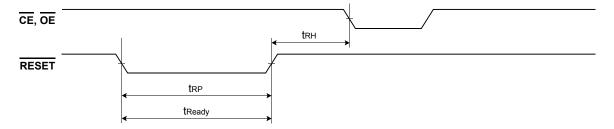
Hardware Reset(RESET)

Parameter	Symphol	All Speed	Unit	
Parameter	Symbol	Min	Max	Unit
RESET Pin Low(During Internal Routines) to Read Mode (Note)	tReady	-	20	μS
RESET Pin Low(NOT During Internal Routines) to Read Mode (Note)	tReady	-	500	ns
RESET Pulse Width*	trp	200	-	ns
Reset High Time Before Read (Note)	tкн	200	-	ns
RESET Low to Standby Mode	trpd	20	-	μs

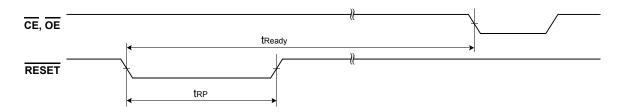
NOTE

Not 100% tested.





Reset Timings NOT during Internal Routines



Reset Timings during Internal Routines

Figure 10. Reset Timings



AC CHARACTERISTICS

Erase/Program Operation

Barrantan	0		All speed options			
Parameter	Symbol	Min	Тур	Max	Unit	
WE Cycle Time(Note 1)	twc	100	-	-	ns	
Address Setup Time	tas	0	-	-	ns	
Address Hold Time	tан	60	-	-	ns	
Data Setup Time	tos	60	-	-	ns	
Data Hold Time	tон	0	-	-	ns	
Read Recovery Time Before Write	tghwl	0	-	-	ns	
CE Setup Time	tcs	0	-	-	ns	
CE Hold Time	tсн	0	-	-	ns	
WE Pulse Width	twp	60	-	-	ns	
WE Pulse Width High	twpн	40	-	-	ns	
Latency Between Read and Write Operations	tsr/w	0	-	-	ns	
Word Programming Operation (Note 2)	tрдм	-	80	-	μS	
Single word Buffer Program (Note 2)	tpgm_bp	-	80	-	μS	
32 words Buffer Program (Note 4)	tpgm_bp	-	320	-	μS	
Accelerated Programming Operation (Note 3)	taccpgm	-	80	-	μS	
Accelerated Single word Buffer Program (Note 3)	taccpgm_bp	-	80	-	μS	
Accelerated 32 words Buffer Program (Note 4)	taccpgm_bp	-	128	-	μS	
Block Erase Operation	tbers	-	0.6	-	sec	
VPP Rise and Fall Time	tvpp	500	-	-	ns	
VPP Setup Time (During Accelerated Programming)	tvps	1	-	-	μS	
Vcc Setup Time	tvcs	50	-	-	μs	



¹⁾ Not 100% tested.

²⁾ Internal programming algorithm is optimized for Buffer Program, so Normal word programming or Single word Buffer Program use
Buffer Program algorithm

³⁾ Internal programming algorithm for supporting Accelerated mode uses a method to double the number of words programmed simultaneously

⁴⁾ Typical 32-words Buffer Program time pays due regard to that Each program data pattern ("11", "10". "01", "00") has a same portion in 32 words Buffer.

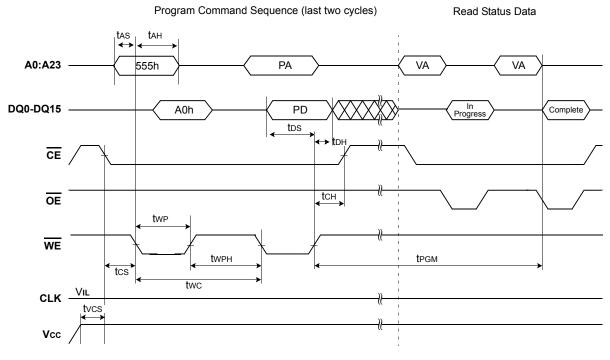
Erase/Program Performance

Parameter –			Limits		Unit	Comments	
		Min.	Тур.	Max.	Unit	Comments	
Block Erase Time	64 Kword	-	0.6	3.0			
Block Erase Time	16 Kword	-	0.3	1.5			
Chip Erase Time		-	154	771	200	Includes 00h programming	
Accelerated Block Erase Time	64 Kword	-	0.4	3.0	sec	prior to erasure	
	16 Kword	-	0.2	1.5			
Accelerated Chip Erase Time		-	103	771			
Word Programming Time		-	80	550			
32 words Buffer Programming Time		-	10	32		Excludes system level over-	
Accelerated Word Programming Time	1	-	80	550	μs / word	head	
Accelerated 32 words Buffer Programming Time		-	4	22			
Chip Programming Time		-	168	537		Excludes system level over-	
Accelerated Chip Programming Time		-	68	370	sec	head	

NOTE

- 1) 25° C, VCC = 1.8V, 100,000 cycles, typical pattern.
- 2) System-level overhead is defined as the time required to execute the two or four bus cycle command necessary to program each
- 3) 100K Program/Erase Cycle in all Bank

SWITCHING WAVEFORMS Program Operations



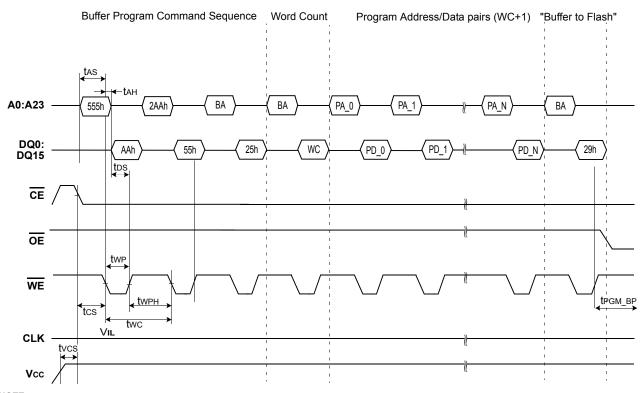
- 1) PA = Program Address, PD = Program Data, VA = Valid Address for reading status bits.
- 2) "In progress" and "complete" refer to status of program operation.
- 3) A16–A23 are don't care during command sequence unlock cycles.

 4) Status reads in this figure is asynchronous read, but status read in synchronous mode is also supported.

Figure 11. Program Operation Timing



SWITCHING WAVEFORMS Buffer Program Operations

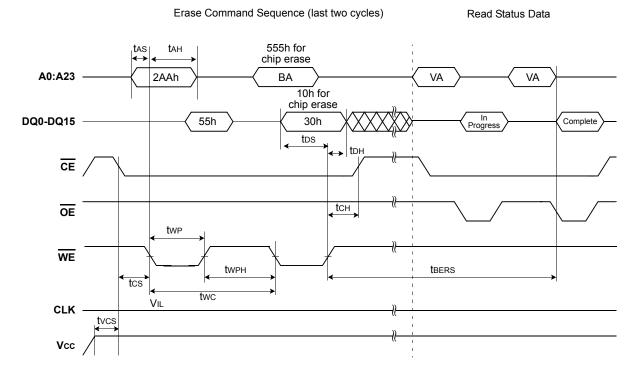


- 1) BA = Block Address, WC = Word Count, PA = Program Address, PD = Program Data, VA = Valid Address for reading status bits.
- 2) Sequential PA_1, PA_2, ..., PA_N must have same address bits A23(max.) ~ A5 as PA_0 entered firstly 3) The number of Program/Data pairs entered must be same as WC+1 because WC = N.
- 4) "In progress" and "complete" refer to status of program operation.
- 5) A16-A23 are don't care during command sequence unlock cycles.
- 6) Status reads in this figure is asynchronous read, but status read in synchronous mode is also supported.

Figure 12. Buffer Program Operation Timing



Erase Operation

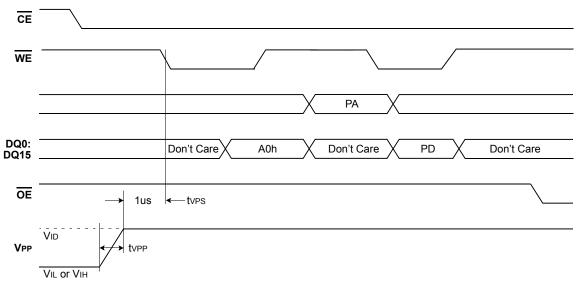


NOTE

- 1) BA is the block address for Block Erase.
- 2) Address bits A16–A23 are don't cares during unlock cycles in the command sequence.
 3) Status reads in this figure is asynchronous read, but status read in synchronous mode is also supported.

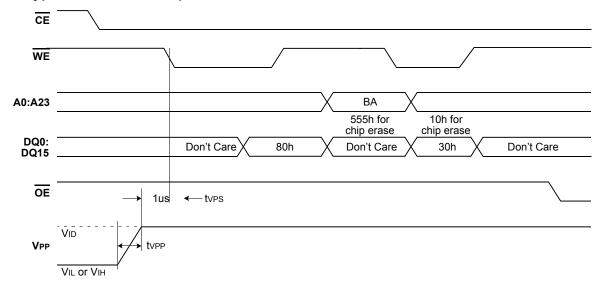
Figure 13. Chlp/Block Erase Operations

SWITCHING WAVEFORMS Unlock Bypass Program Operations(Accelerated Program)





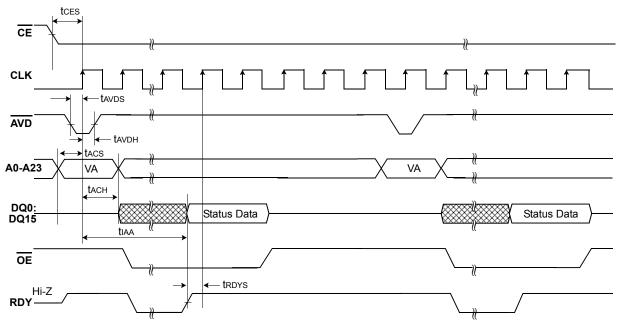
Unlock Bypass Block Erase Operations



- 1) VPP can be left high for subsequent programming pulses.
- 2) Use setup and hold times from conventional program operations.
 3) Conventional Program/Erase commands as well as Unlock Bypass Program/Erase commands can be used when the VID is applied to Vpp.

Figure 14. Unlock Bypass Operation Timings

SWITCHING WAVEFORMS Data Polling Operations

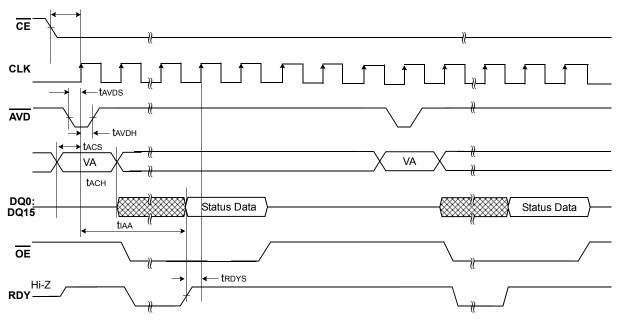


VA = Valid Address. When the Internal Routine operation is complete, and Data Polling will output true data.

Figure 15. Data Polling Timings (During Internal Routine)



Toggle Bit Operations



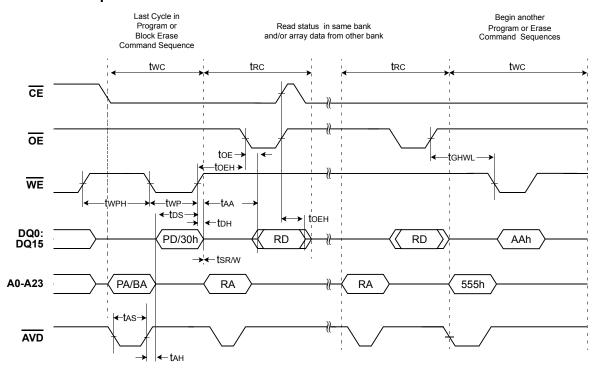
NOTE

VA = Valid Address. When the Internal Routine operation is complete, the toggle bits will stop toggling.

Figure 16. Toggle Bit Timings(During Internal Routine)

SWITCHING WAVEFORMS

Read While Write Operations



Breakpoints in waveforms indicate that system may alternately read array data from the "non-busy bank" and checking the status of the program or erase operation in the "busy" bank.

Figure 17. Read While Write Operation



Crossing of First Word Boundary in Burst Read Mode

The additional clock insertion for word boundary is needed only at the first crossing of word boundary. This means that no additional clock cycle is needed from 2nd word boundary crossing to the end of continuous burst read. Also, the number of additional clock cycle for the first word boundary can vary from zero to fourteen cycles, and the exact number of additional clock cycle depends on the starting address of burst read and programmable wait state settings. For example, if the starting address is 16N+15 (the worst case) and programmable wait state setting(A<14:11>) is "0011" (which means data is valid on the 7th active CLK edge after AVD transition to Vih), six additional clock cycle is needed.

Similarly, if the starting address is 16N+15 (the worst case) and programmable wait state setting(A<14:11>) is "0010" (which means data is valid on the 6th active CLK edge after $\overline{\text{AVD}}$ transition to Vih), five additional clock cycle is needed.

Below table shows the starting address vs. addtional clock cycles for first word boundary.

Starting Address vs. Additional Clock Cycles for first word boundary

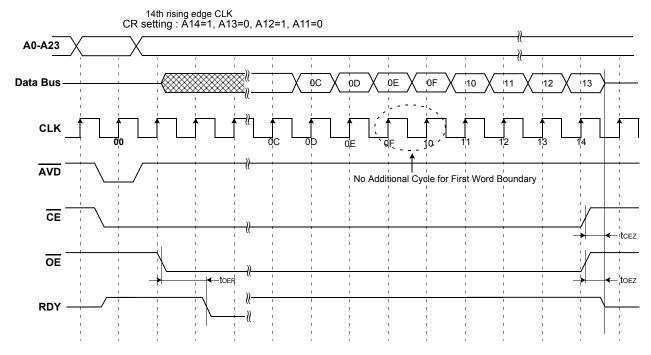
Srarting		LSB Bits	Additional Clock Cycles for First Word Boundary (note1)							
Address Group for Burst Read	The Residue of (Address/16)	of Address	A<14:11> "0000" Valid data : 4th CLK	A<14:11> "0001" Valid data : 5th CLK	A<14:11> "0010" Valid data : 6th CLK		A<14:11> "1011" Valid data : 15th CLK			
16N	0	0000	0 cycle	0 cycle	0 cycle		0 cycle			
16N+1	1	0001	0 cycle	0 cycle	0 cycle		0 cycle			
16N+2	2	0010	0 cycle	0 cycle	0 cycle		1 cycle			
16N+3	3	0011	0 cycle	0 cycle	0 cycle		2 cycle			
16N+4	4	0100	0 cycle	0 cycle	0 cycle		3 cycle			
16N+5	5	0101	0 cycle	0 cycle	0 cycle		4 cycle			
16N+6	6	0110	0 cycle	0 cycle	0 cycle		5 cycle			
16N+7	7	0111	0 cycle	0 cycle	0 cycle		6 cycle			
16N+8	8	1000	0 cycle	0 cycle	0 cycle		7 cycle			
16N+9	9	1001	0 cycle	0 cycle	0 cycle		8 cycle			
16N+10	10	1010	0 cycle	0 cycle	0 cycle		9 cycle			
16N+11	11	1011	0 cycle	0 cycle	1 cycle		10 cycle			
16N+12	12	1100	0 cycle	1 cycle	2 cycle		11 cycle			
16N+13	13	1101	1 cycle	2 cycle	3 cycle		12 cycle			
16N+14	14	1110	2 cycle	3 cycle	4 cycle		13 cycle			
16N+15	15	1111	3 cycle	4 cycle	5 cycle		14 cycle			

NOTE

Address bit A<14:11> means the programmable wait state on burst mode configuration register. Refer to Table 7.



Case1: Start from "16N" address group

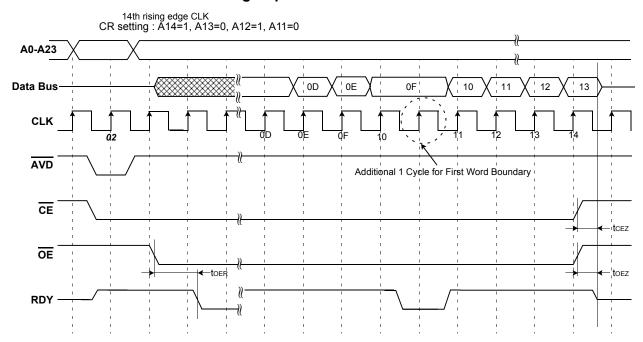


NOTE

- 1) Address boundry occurs every 16 words beginning at address 000000FH, 000001FH, 000002FH, etc.
- 2) Address 0000000H is also a boundry crossing.
- 3) No additional clock cycles are needed except for 1st boundary crossing.

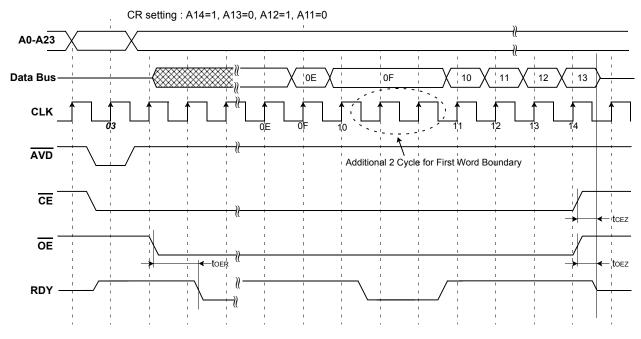
Figure 18. Crossing of first word boundary in burst read mode.

Case2: Start from "16N+2" address group





Case3: Start from "16N+3" address group



NOTE

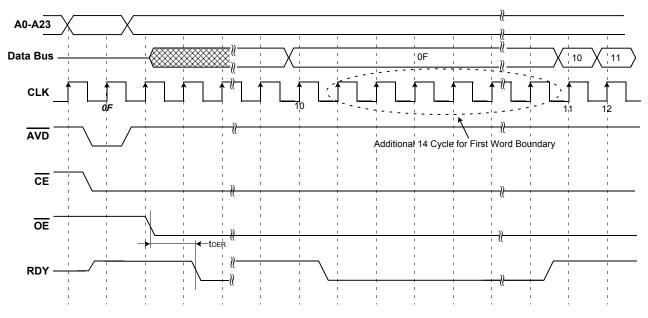
- 1) Address boundry occurs every 16 words beginning at address 000000FH, 000001FH, 000002FH, etc.
- 2) Address 0000000H is also a boundry crossing.

 3) No additional clock cycles are needed except for 1st boundary crossing.

Figure 19. Crossing of first word boundary in burst read mode.

Case4: Start from "16N+15" address group

14th rising edge CLK CR setting : A14=1, A13=0, A12=1, A11=0



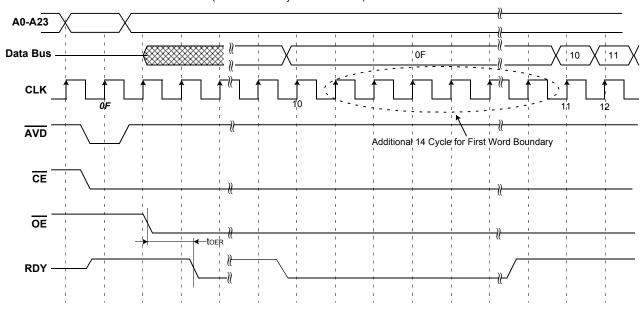
- 1) Address boundry occurs every 16 words beginning at address 000000FH , 000001FH , 000002FH , etc. 2) Address 0000000H is also a boundry crossing.
- 3) No additional clock cycles are needed except for 1st boundary crossing.

Figure 20. Crossing of first word boundary in burst read mode.



Case5: Start from "16N+15" address group

14th rising edge CLK CR setting : A14=1, A13=0, A12=1, A11=0 A18=1(RDY set One cycle before data)



- 1) Address boundry occurs every 16 words beginning at address 000000FH, 000001FH, 000002FH, etc.
 2) Address 0000000H is also a boundry crossing.
 3) No additional clock cycles are needed except for 1st boundary crossing.
 4) RDY setting behaves same way both case in crossing a word boundary and valid data on the output.

 Figure 21. Crossing of first word boundary in burst read mode.

